

The designs of the master and slave CCB FPGAs

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Abstract

The aim of this document is to detail the design of the CCB FPGA firmware, and define its interfaces to the rest of the CCB hardware. The design will be presented in a hierarchical manner, starting with block diagrams of major components and their interconnections, and ending with the VHDL code that synthesizes the lowest level components displayed, and connects them together.

[This is still a work in progress]

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Chapter 1

Introduction

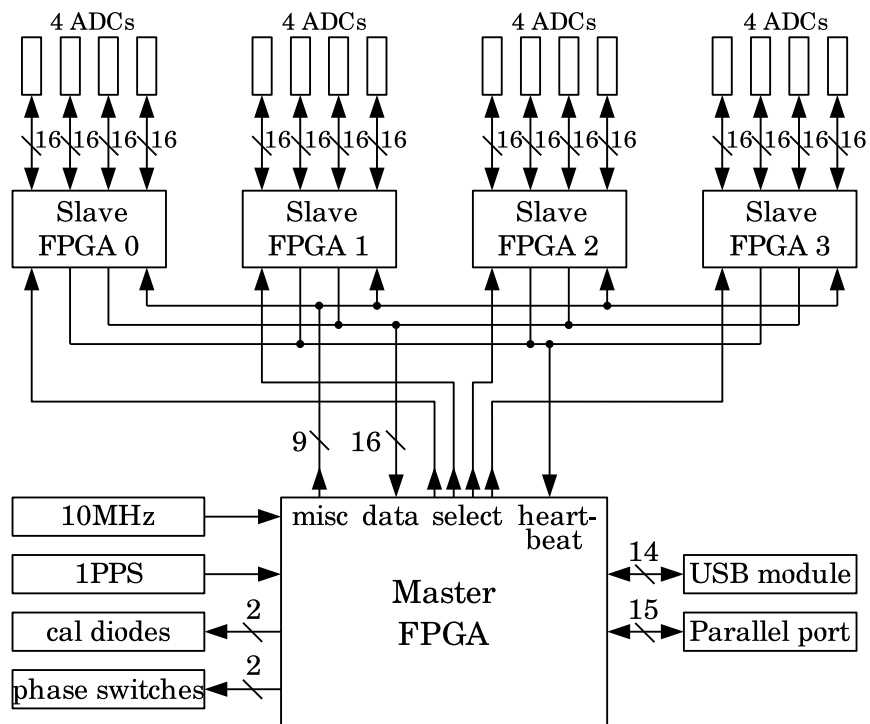


Figure 1.1: An overall summary of the FPGA connections

Figure 1.1 shows the overall architecture of the FPGAs with respect to the rest of the CCB. At the heart of the system, the Master FPGA controls 4 slave FPGAs, receives commands and sends interrupts and read-back configuration parameters, via the computer's EPP parallel port, dispatches observed data to the computer over a USB link, and controls calibration diodes and phase switches in the receiver, via opto-isolated output cables. All of its timing signals are derived from the Green Bank 10MHz and 1PPS reference signals.

Under the direction of the Master FPGA, each of the slave FPGAs continuously reads 14-bit data samples from 4 ADCs at 10MSPS, and either integrates these samples until told to deliver them to the Master FPGA, or, when in dump mode, delivers them un-integrated to the Master FPGA.

The following two chapters detail the internal logic and external interconnections of the Slave and Master FPGAs, respectively.

Chapter 2

The slave FPGAs

There are 4 slave FPGAs controlled by one master FPGA. All of the slave FPGAs are identical, so this chapter documents the internal components, and external I/O connections of a single slave FPGA. Figure 2.1 shows the layout of a slave FPGA, showing the major logic components within the FPGA, the internal interconnections between these components, and all of the external I/O-pin connections to the 4 ADCs to the left, and to the master FPGA, shown at the bottom of the diagram.

2.1 An overview of the internals of a slave FPGA

Starting from the left hand-side of the diagram, DCM1 generates a phase-shifted copy of the main FPGA clock-signal. This signal clocks the 4 external ADCs, and latches their samples into input registers within the associated *Sampler* components. The *Sampler* components take either these latched samples, as their input samples, or fake pseudo-random samples from the *Signal Injector* component, according to the state of the **test** control-signal. The selected input samples are then both reproduced at the **raw** outputs of the *Sampler* components, and integrated between assertions of the **start** signal. Each new sample is integrated by adding it to one of 4 phase-switch bins, as directed by the **phase** control-signal. When the master FPGA commands the start of a new integration period, by asserting the **start** signal, the contents of the phase-switch integration bins are copied into output buffers, then the bins are cleared for the first sample of the next integration period. The output buffers take the form of PISOs (Parallel In Serial Out). The **sin** inputs and **sout** outputs of the PISOs within each *Sampler* component, are chained together to form one long PISO that contains the final integrations of all of the *Sampler* components. The **select** control-signal enables tri-state drivers that allow the contents of the PISO to be clocked out by the **strobe** input signal, applied to the **shift** signals of all of the *Sampler* components. **Latch3** ensures that the first sample isn't read out until the first strobe signal edge that follows the **select** signal being asserted. This allows the tri-state drivers to be enabled and have time to settle

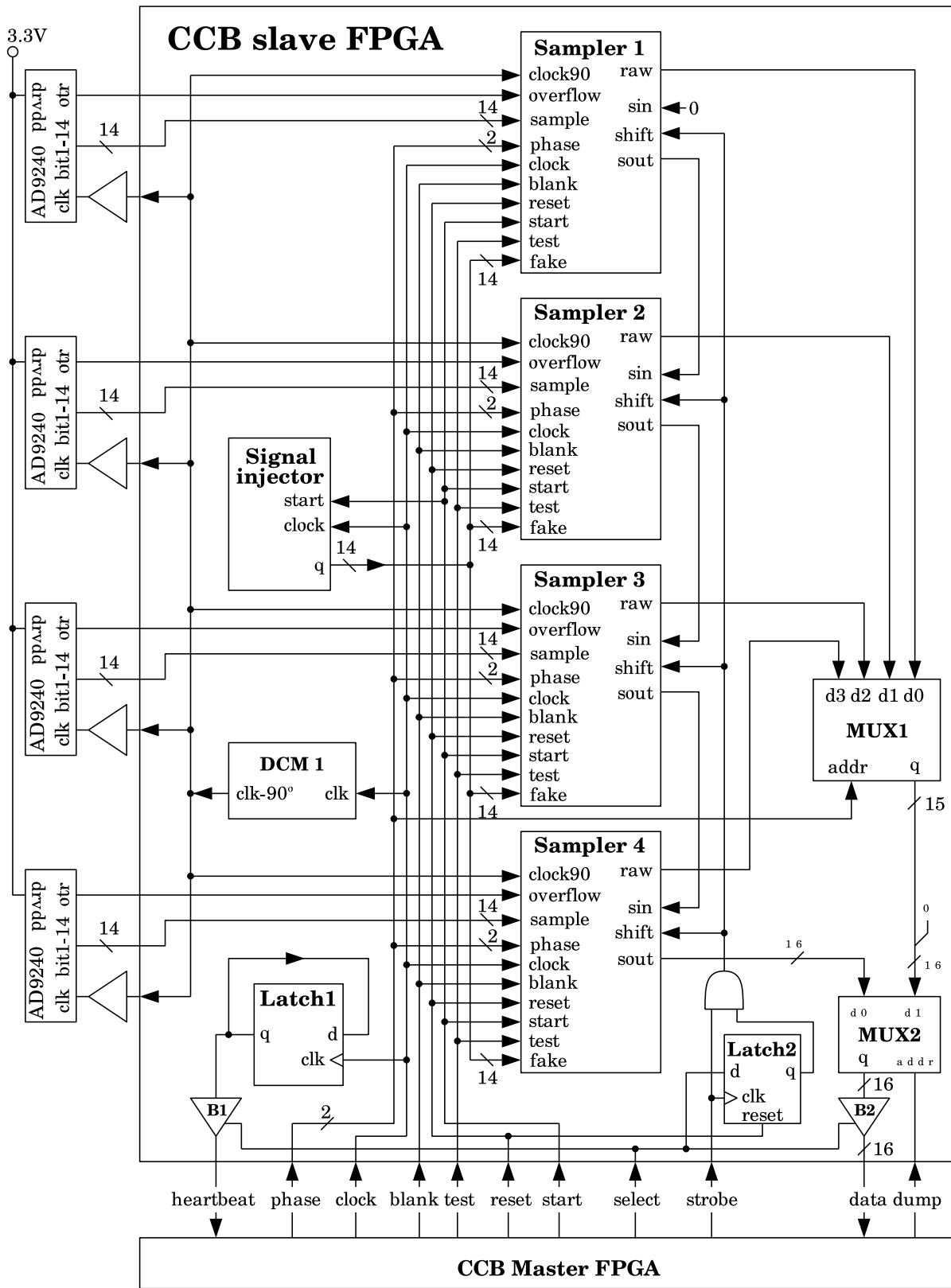


Figure 2.1: The top-level design of the slave FPGA

before the initial output sample of the PISO is replaced with the next, and thus lets the *Data Dispatcher* read-out the initial sample, as it pulses the `strobe` signal to request the next sample.

The source of the output `data` signal of a slave FPGA is determined by *MUX2*, which selects the output of the integration PISO, in normal integration mode, or one of the raw *Sampler* outputs, when in dump mode. In dump mode, the `phase` control-signal is re-interpreted by *MUX1*, as the address of the *Sampler* whose raw samples are to be passed to the output, via *MUX2*.

The `heartbeat` output signal of the slave FPGA is used by the master FPGA, while the slave is selected for readout, to determine if the slave is present and showing signs of life. Since an FPGA that has been fried, or has failed to load its firmware, could unpredictably present any signal on its I/O pins, the `heartbeat` output is designed to present a dynamic signal, with a known pattern that the master FPGA can check for. The pattern is simply a signal which toggles its state at each successive rising edge of the input clock. The master FPGA checks this at the start of each clock cycle, simply by using an XOR gate to compare a latched copy of the previous state of the `heartbeat` signal, to its current state. If the old and new heartbeat values of a given slave, aren't opposites, then that slave is flagged in the output data that are sent to the CCB computer. Note that the heartbeat output, which shares a single input to the master FPGA, is placed in a high impedance state except when the master selects the slave for readout.

Note that in normal integration mode, new integrations are ready to be read-out from the slave's output PISO on the second rising clock-edge that follows the rising edge of the `start` signal.

2.1.1 The Signal Injector

The job of the *Signal Injector* is to generate repeatable pseudo-random fake ADC samples, for optional use by the *Sampler* components, in place of real ADC samples. The implementation, as shown in figure 2.2, is a conventional linear-feedback shift-register, configured to generate 14-bit random positive integers. The sequence of random numbers repeats every $2^{14} - 1$ clock cycles, and within this period, each number between 1 and $2^{14} - 1$ is generated exactly once. To ensure that the results are repeatable for each integration, the sequence is re-started whenever the master FPGA asserts the `start` signal. This is done by asserting the `set` input of the shift-register, which sets all of the bits of the shift-register to 1.

Note that if the value of the shift-register somehow becomes zero, then the generation of random numbers ceases. However, although glitches could potentially force the register into this state, the correct sequence would be started anew at the start of the next integration period, so automatic restarting hasn't been included. Automatic restarting would be of dubious utility anyway, since the operator wouldn't see the repeatable test-sequence that they were expecting, if the sequence were restarted in the middle.

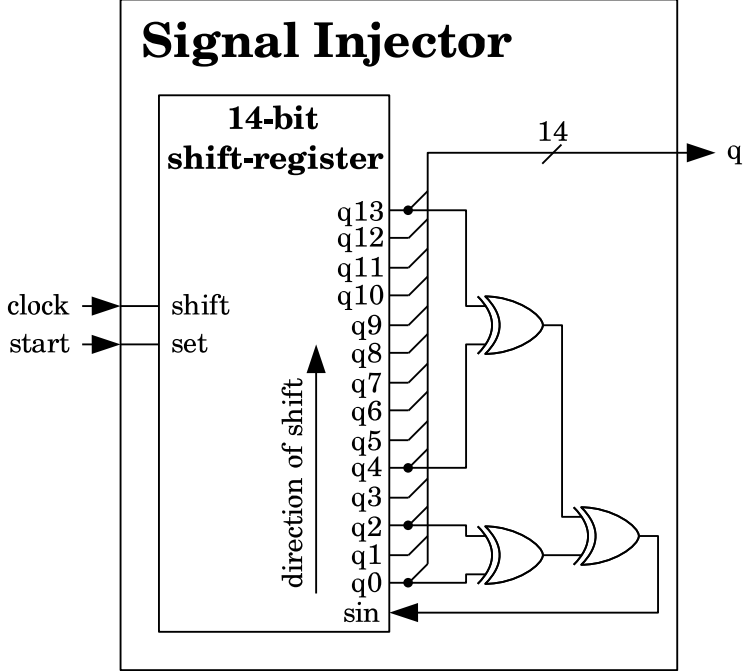


Figure 2.2: The Signal Injector component

2.1.2 The Sampler component

The job of the *Sampler* component is to acquire raw samples from the ADC, integrate either these samples or fake ADC samples, into phase-switch bins, and present both the resulting integrations, and the real or fake samples, for collection by the master FPGA. The implementation is shown in figure 2.3.

Register *Reg1* uses the phase-shifted ADC clock to acquire each new ADC sample and overflow signal from the external ADC. Multiplexer *MUX1* then takes either this sample and overflow, or a fake sample, with no overflow, and presents these to integrator, *Integrator1*, for integration into phase-switch bins. It also routes them to the **raw** output of the *Sampler*, for collection in dump mode.

Integration into phase-switch bins is performed by *Integrator1*. Within this component, each new sample is either ignored, if the **blank** signal is asserted, or added to the phase-switch integration bin that is specified by the 2-bit **phase** input. If the input sample either has its overflow bit asserted, or its addition to the integration would overflow the 32-bit integration-bin, then the contents of the integration-bin are replaced with a 32-bit number having all bits set to 1, and thereafter, this state persists until the bin is reset for the next integration period.

The end of one integration period, and the start of the next, is signaled by the **start** input

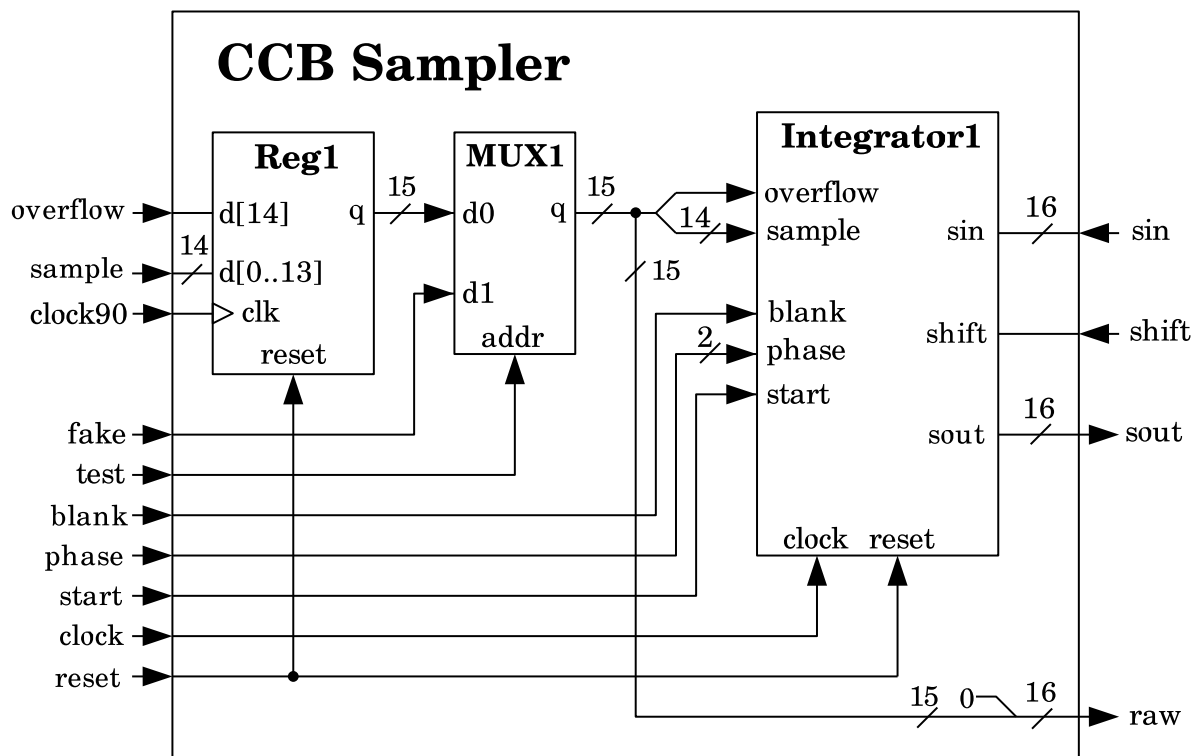


Figure 2.3: The Sampler component

signal. When this is asserted, the contents of the integration bins are copied into an output PISO, within the integrator component, as the integration bins are being reset for the new integration. All bins, except possibly for the currently selected bin, are reset by zeroing their contents. If the `blank` input is asserted, then the number in the currently selected bin is similarly reset to zero. Otherwise it is replaced with the value of the first sample of the new integration period.

Although the integration bins are 32 bits wide, there are only 16 I/O pins available for transmitting data from each slave FPGA to the master FPGA. Thus, within the slaves, the chain of 16-bit PISOs of each of the *Sampler* components, is used to feed the master one 16-bit half of an integration result, each time that the master clocks the `strobe` input of the slave. For each integration-bin, the 16 least significant bits of the bin contents are read out first, followed by the 16 most significant bits.

2.1.3 The Integrator component

The function of the *Integrator* component has already largely been described in the documentation of the *Sampler* component, so this section just describes its implementation, which is shown in figure 2.4.

Most of the work of an *Integrator* component is performed by four embedded *Accumulator* components, each of which represents one of the 4 phase-switch integration bins. Although each new sample is seen by all of the *Accumulator* components, only the *Accumulator* whose `select` input is asserted, considers the sample for addition. The `phase` input, decoded by the *Decoder* instance, thus determines which *Accumulator* gets the latest sample, at the start of each new clock cycle.

The individual *Accumulator* components contain small PISOs that are chained by the parent *Sampler* component, to form the PISO that the parent *Sampler* clocks.

2.1.4 The Accumulator component

The *Accumulator* component accumulates the samples of a particular phase-switch integration bin, as described in the documentation of the *Sampler* component. Its implementation is shown in figure 2.5.

In the diagram, the *Adder* component and register, `Reg0`, form the accumulator cell used to integrate successive samples. This updates every clock cycle, despite samples only being added when the `select` input is asserted. On clock cycles when either the `select` input is not asserted, or the `blank` input is asserted, then AND gate `A2` replaces the input-sample with zero, so that nothing gets added to the accumulator. The previous value of the accumulator cell is fed to the `d0` input of the adder, to be added to, except when the cell is being reset

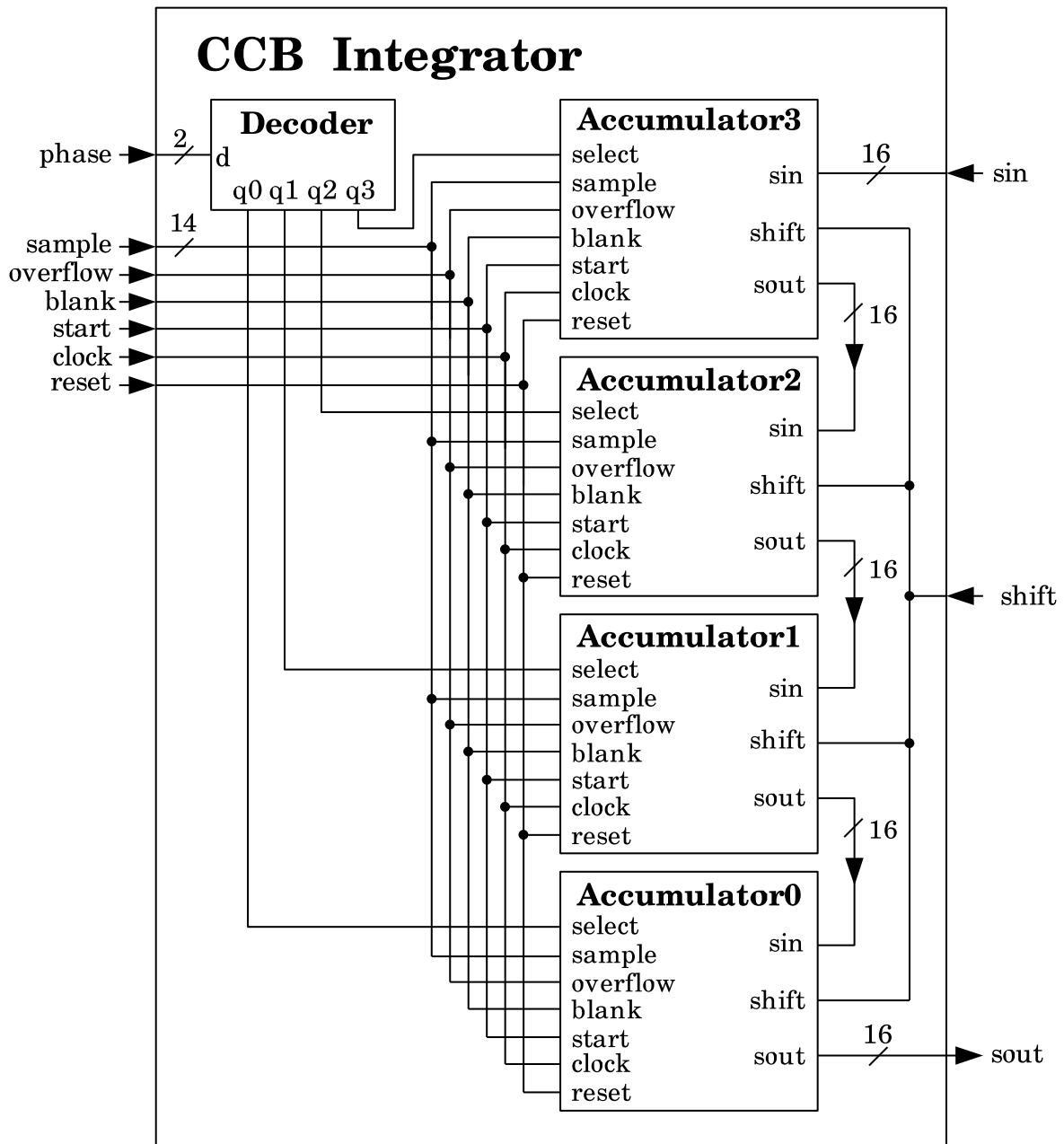


Figure 2.4: The Integrator component

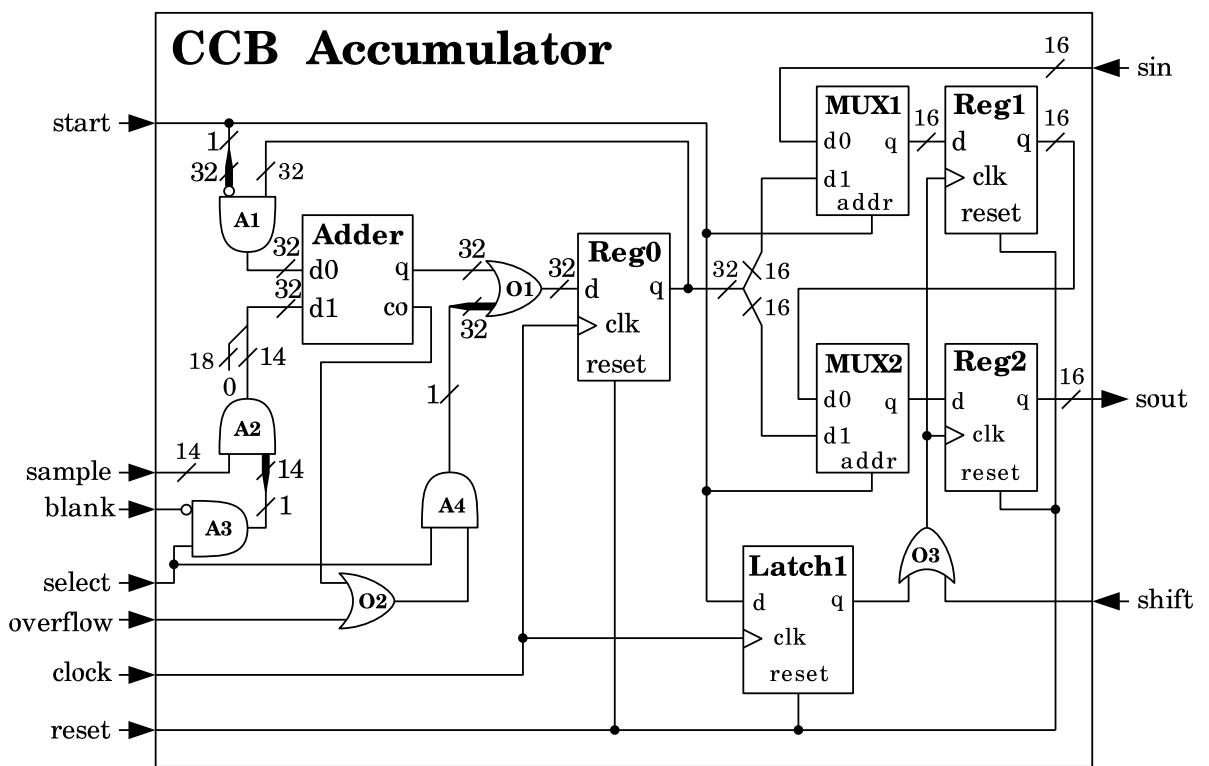


Figure 2.5: The Accumulator component

for a new integration. In the latter case, AND gate A1, changes the value at the d0 input to zero. Thus, when the `start` signal is asserted, to start a new integration, the adder replaces the accumulator value with either zero, if either the accumulator isn't currently selected, or the `blank` input is asserted, or with the first sample of the new integration, otherwise.

When the *Accumulator* is selected, if either its `overflow` input is asserted, or the output of the adder overflows, OR gate O1 replaces the output of the adder with a 32-bit value with all bits 1. Since all further non-zero additions to this maximal value re-trigger this feature, this value persists until the start of the next integration period, when the accumulator cell is reset.

Multiplexers MUX1 and MUX2, and registers Reg1 and Reg2, form the two-entry 16-bit-wide output PISO of the *Accumulator* component. At the end of the first clock cycle of a new integration period, following the `start` signal going high, the accumulator register is reset with the corresponding output of the adder, while the previous output of the accumulator register is latched into the two registers of the PISO by the delayed `start` signal, coming from latch Latch1. By the time that this happens, the `addr` inputs of the two PISO multiplexers have had most of a clock cycle to settle at the asserted value of the `start` signal. Thus the signals at the d1 inputs of the multiplexers are routed to the d inputs of the 2 PISO registers, and latched into these registers. The 16 bit input that ends up in Reg1, is the upper half of the 32-bit accumulator register value, while Reg2 gets the lower half. On subsequent clock cycles, the `start` signal is no longer asserted, so the `addr` inputs of the two PISO multiplexers are 0. This routes the `sin` input of the *Accumulator* component to the input of register Reg1, the output of Reg1 to the input of Reg2, and the output of Reg2 to the `sout` output of the *Accumulator* component. Thus whenever there is a rising clock edge on the `shift` input of the *Accumulator* component, the contents of Reg2 get replaced with the previous contents of Reg1, while the contents of Reg1 get replaced with the value at the `sin` input.

2.1.5 The ADC clock signal

Note that the clock signal that is transmitted to the ADCs, and to the input registers within the *Sampler* components, is a phase shifted version of the FPGA clock, and is generated by one of the “Digital Clock Managers” of the parent Spartan-3 FPGA. On the CCB mailing list a preference for a 90° phase shift was expressed. This could be +90°, or as tentatively shown in the diagram, -90°.

The data-sheet of the AD9240 ADC says that the time taken between a rising clock edge at the ADC clock input, and a valid new sample being available at the ADC data outputs, ranges from between 8ns to 19ns. Thus if the ADC clock were generated by shifting the FPGA clock by +90° (ie. 25ns), then this would leave a minimum of 6ns between the time that valid data appeared at the data outputs of the ADC, and the time that the input registers in the FPGA attempted to latch this data. This seems rather a short time, given that the data outputs will presumably have to traverse PCB tracks, connectors, and the

input capacitance of the FPGA pins, before arriving at the inputs of the registers. Thus, in the diagram, the alternative -90° phase-shift is indicated instead. This means that the registers latch the data at least 56ns after they become valid, and 25ns before the ADC next samples its inputs.

In practice, the *Digital Clock Managers* can be programmed to generate practically any phase shift, so the choice of phase-shift need not be set in stone at this point, and can be changed if testing proves that the initial choice was a bad one. This also means that the choice of whether to use inverting or non-inverting external clock buffer-amplifiers is unimportant, since either can be accommodated by selecting a different phase shift.

2.1.6 External connections

The FPGA I/O pins should be configured for 3.3V logic levels.

Provided that the DRVDD pins of the ADCs are connected to a 3.3V power-supply, then the output data pins of the ADCs can directly drive the corresponding input pins of the FPGA. This may not be the case if there are cables or filters in between. Unfortunately, the ADC clock input appears to require higher CMOS levels, regardless of the voltage at the ADC DRVDD pin. Hence the individual 3.3V to CMOS buffer amplifiers between the FPGA clock output pins and the ADC clock input pins. If the clock output pins of the FPGA are close together, then presumably the number of FPGA clock output pins could be reduced; as could the number of separate buffer chips.

Chapter 3

The master FPGA

Figure 3.1 shows the layout of the master FPGA, showing its major internal components, along with their interconnections, and all of the external I/O-pin connections to external chips. The central brain of this design, is the *State Generator* component, which orchestrates the timing and the values of all control signals that go to the other components and the slave FPGAs. The *State Generator* is in turn told what to do by the computer, via the *Control Gateway* component, which handles all interactions with the parallel port interface. The *Data Dispatcher* component is responsible for sending integrated and dump-mode data to the computer, via the USB interface.

3.1 The Control Gateway

The *Control Gateway* handles all interactions with the CCB computer's EPP parallel port interface. It provides an 8-bit register-based interface for the CPU to use to send commands and configuration data to the *State Generator*, allows read-back of these same registers, and lets the *State Generator* interrupt the CPU via the parallel port interrupt line.

In addition, the reset signal of the EPP parallel port can be used at any time by the device driver in the CCB computer, to reset the firmware and the USB chip. This will automatically be done whenever the device driver is newly loaded.

The implementation of an 8-bit register-based interface, for use by the computer, is simplified by the built-in support for separate address and data cycles in standard EPP hardware. Since both of these targets have read and write cycles, there are 4 distinct I/O cycles, which are assigned to CCB operations as follows:

- **The address write-cycle**

The associated data-byte is interpreted as the address of one of the registers in the

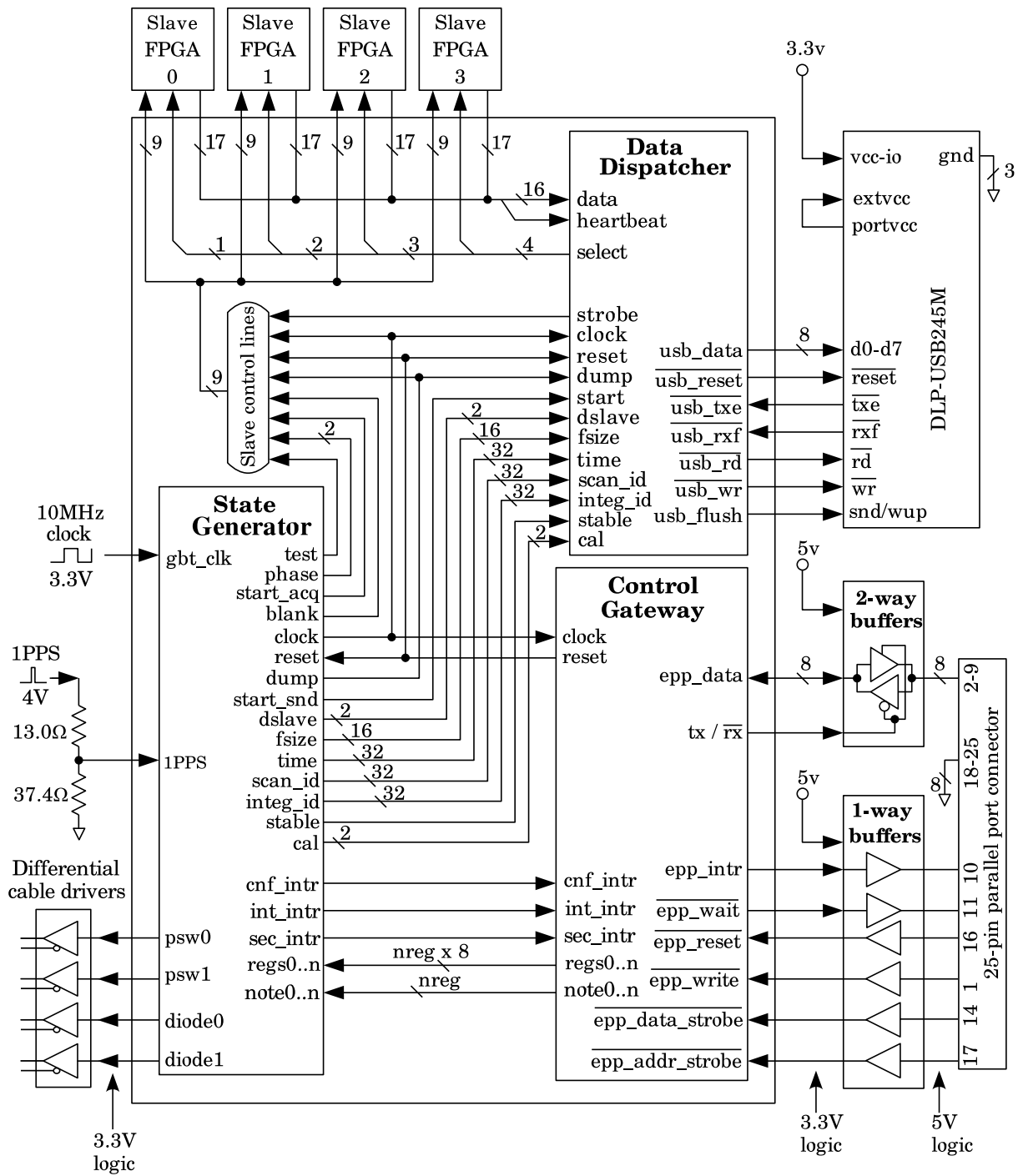


Figure 3.1: The top-level design of the master FPGA

FPGA. Subsequent data-read and data-write cycles read from and write to the addressed register.

- **The data write-cycle**

The associated data-byte is copied into the register that was indicated during the last address write.

- **The data read-cycle**

The returned data-byte is the value of the register that was indicated during the last address write.

- **The address read-cycle**

When the CPU initiates an address-read cycle, the FPGA responds by returning the bit-mask of all FPGA event-sources that have requested interrupts since the last time that the computer executed an address-read cycle.

There are only two periods when data are sent to the master FPGA by the computer.

1. When starting a new scan, a write to the control register is used to prepare the *State Generator* for reconfiguration. This is followed by multiple EPP write-cycles to send the configuration data of the new scan. The last such write is to the register which instructs the *State Generator* to activate the new scan.

Note that since the FPGA does nothing with the configuration data that it is sent, until it is told to start the next scan, it is safe to send the values of multi-byte configuration registers, one byte at a time.

2. During a scan, the CPU sends the FPGA a single byte of integration-specific configuration data whenever the FPGA generates a configuration interrupt. At the start of a scan, this happens repeatedly, until the FIFO that queues these bytes fills up. Thereafter, integration-configuration interrupts are sent at the end of each integration, as the removal of one integration-configuration byte from the FIFO, makes room for another.

Since between scans, only the integration-configuration register is written to, the device driver need not keep sending the address of the integration-configuration register before each data write. Instead it sends it once, just after the command byte that activates a new scan.

Thus, on average, each such interrupt will cause an EPP address-read to get the interrupt mask, plus one EPP write to send the FPGA the configuration of the next un-configured integration. Once the configuration FIFO is full, this happens once per integration.

3.1.1 The internals of the Control Gateway

When configuration data and commands are received from the computer, they are recorded in a bank of 8-bit registers. The values stored in this bank of registers are included in the outputs of the *Control Gateway*, and are thus visible to the rest of the CCB, where the individual registers are interpreted, either as commands to be executed on receipt, or as configuration data. The registers are updated synchronously with the FPGA clock, followed, one cycle later, by a corresponding output flag which indicates, for one clock cycle, when a new value for that register has been received. The bytes in the *EPP Register Bank* can also be read-back by the CPU, via EPP data-reads.

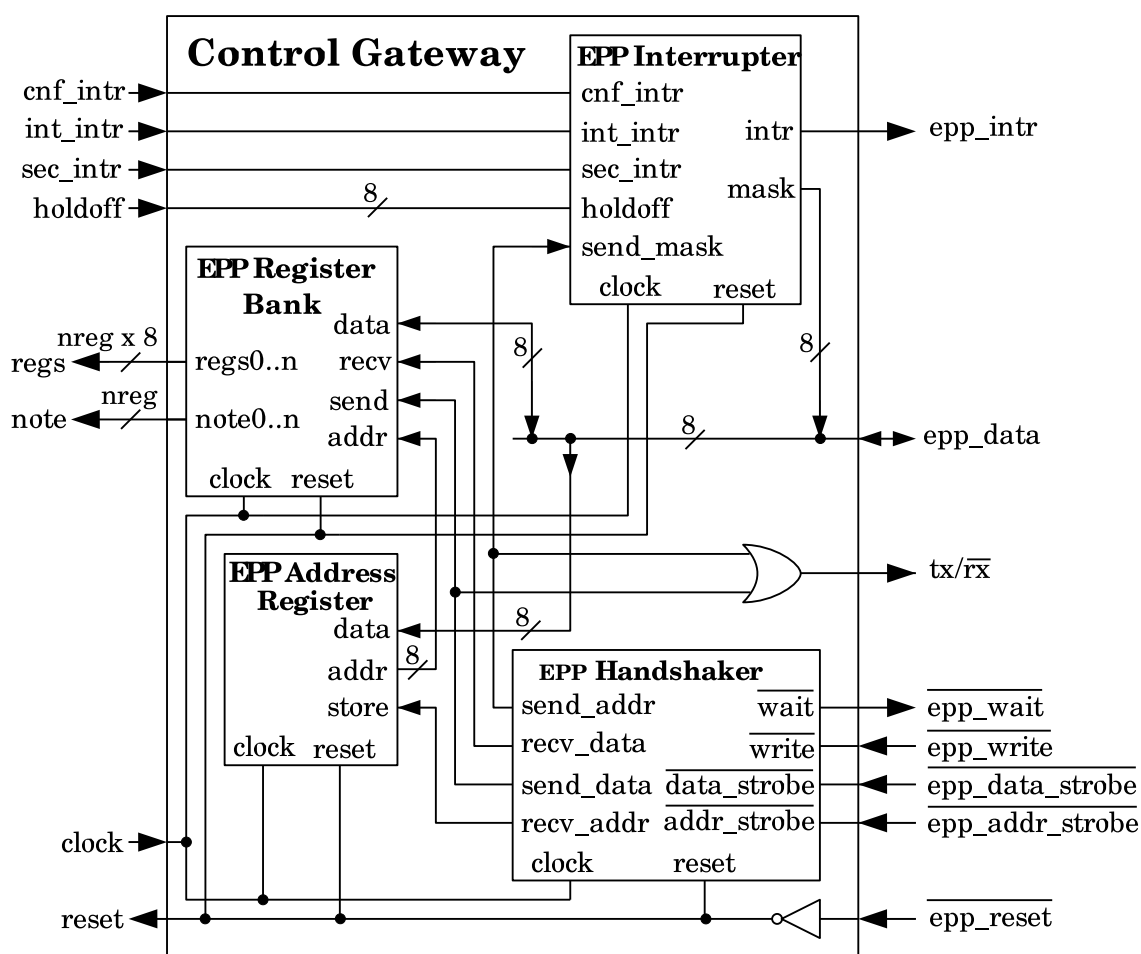


Figure 3.2: The Control Gateway

Since only one register can be read from or written to by the CPU in a single EPP transaction, a way is needed for the CPU to specify which register is to be the current I/O target. As previously mentioned, to do this, the CPU uses an EPP address-write transaction to send the 8-bit address of the register of interest. On receiving such an address, the *Control Gateway*

stores it in the *EPP Address Register* whose output is used to route subsequent EPP data transactions to the specified register in the *EPP Register Bank*.

The *EPP Interrupter* allows multiple interrupt sources in the FPGA to share the single parallel-port interrupt line. When the CPU receives a parallel-port interrupt, it responds by performing an EPP address-read, which both acknowledges the interrupt, and asks the FPGA which FPGA event-sources requested the interrupt. The *EPP Interrupter*, which is told about the address-read by the *EPP Handshaker*, responds by sending the CPU an 8-bit interrupt mask, whose individual bits indicate which event-sources have requested interrupts since the last time that the mask was read by the CPU.

The *EPP Interrupter* has a `holdoff` input, whose value is the minimum number of clock cycles to wait after sending one interrupt, before sending another. This both prevents interrupts from being sent too frequently, and sets the rate at which unacknowledged interrupts are to be re-sent. Note that there is no danger that a re-sent interrupt will be interpreted by the CPU as indicating two events in the FPGA, since it is the contents of the interrupt mask, rather than the number of interrupts received, that matters, and the mask is automatically cleared as part of the read operation.

To avoid a tug-of-war with the CPU, the FPGA only drives the `data` lines when explicitly requested, as indicated by either of the `send_data` or `send_addr` outputs of the *EPP Handshaker* being asserted. Thus the external `data` line transceivers are configured to passively receive data from the computer, except when either of the former signals are asserted.

The EPP Handshaker

The *EPP Handshaker* module, as depicted in figure 3.4, is responsible for responding to the standard EPP handshaking signals for all single-byte EPP transfers.

The timings of the two standard EPP I/O cycles are shown in figure 3.3. Note that the `strobe` signal represents either the `addr_strobe` or `data_strobe` signals, depending on whether an address-write or data-write cycle is in progress, and that the `write`, `data_strobe`, `addr_strobe`, and `wait` EPP signals are all active-low. The `write` and `strobe` signals are generated by the computer, while the `wait` signal is generated by the FPGA. The 8-bit `data` signal is generated by the computer when performing an EPP write-cycle, and by the FPGA when performing an EPP read-cycle.

At the start of each FPGA clock-cycle, the value of the `wait` signal is derived from the previous value of this signal, from the value of the `write` signal, and from the value of the appropriate strobe signal, according to the truth table shown to the right of figure 3.4. The circuit within the dashed box implements this truth-table.

The `data_strobe` and `addr_strobe` inputs, to the circuit in the dashed-box, are pre-conditioned by latches 1 and 2, which both re-time them to rise and fall in sync with the FPGA clock,

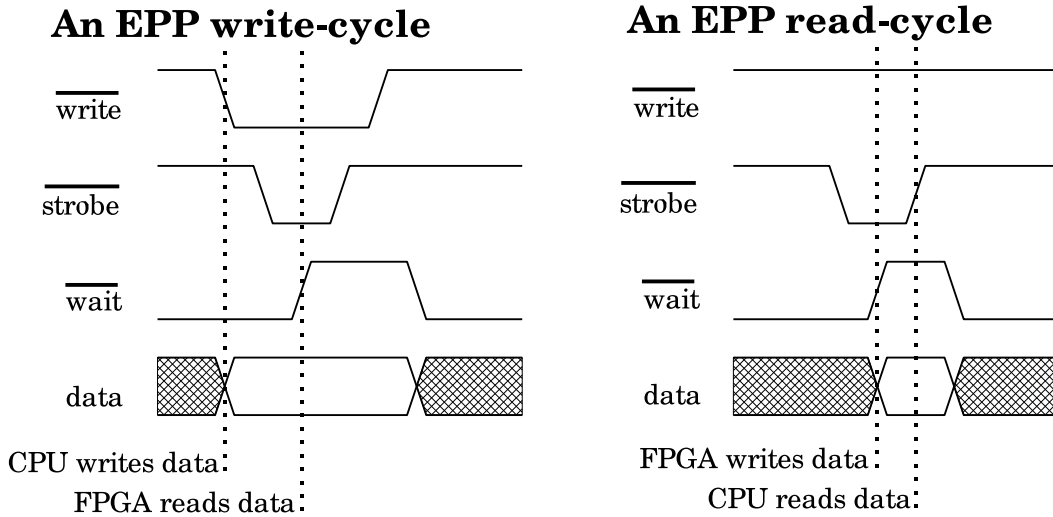


Figure 3.3: The standard EPP I/O cycles

and invert them. All of the logic paths that follow them have a full clock cycle to settle, before being latched by latches 3-7. In particular, when a rising edge of either of the EPP $\overline{\text{data_strobe}}$ or $\overline{\text{addr_strobe}}$ signals violates the setup and hold times of latches 1 and 2, the corresponding latch could go into a metastable state, so this extra clock-cycle for the metastable state to work itself out, should greatly increase the reliability of the circuit. Indeed, apparently the conventional recommendation for interfacing asynchronous logic to clocked logic is to use two chained latches like this. The drawback of this is that it adds a clock cycle to the handshaking delay, and thus reduces the possible throughput. However, since the CCB won't be streaming large amounts of data through the parallel port, this shouldn't be important. If it were a problem, the simplest solution would be to increase the FPGA clock frequency to make one FPGA clock cycle less than half the duration of the standard EPP 8MHz clock period, although this would of course involve a trade off, since the probability of a metastable state persisting for the shorter period of the higher frequency clock, would then be higher.

The bottom line is that the rising edge of the output $\overline{\text{wait}}$ signal follows the falling edge of the pertinent $\overline{\text{strobe}}$ signal by between 1 and 2 FPGA 10MHz clock cycles, which corresponds to 0.8 and 1.6 EPP 8MHz clock cycles. Thus most of the time, the standard 4-cycle EPP I/O transaction will be lengthened to 5 8MHz cycles, and thus last $0.625\mu\text{s}$ instead of $0.5\mu\text{s}$.

Note that the $\overline{\text{wait}}$ and $\overline{\text{write}}$ signals aren't pre-latched, like the $\overline{\text{strobe}}$ signals, since the EPP protocol assures that they will have stabilized before the pertinent $\overline{\text{strobe}}$ signal is driven low, and remain stable until after the $\overline{\text{wait}}$ line is next driven high.

While it drives the EPP $\overline{\text{wait}}$ signal high, the *EPP Handshaker* also asserts one of the send_data , recv_data , send_addr , and recv_addr outputs, both to indicate what type of

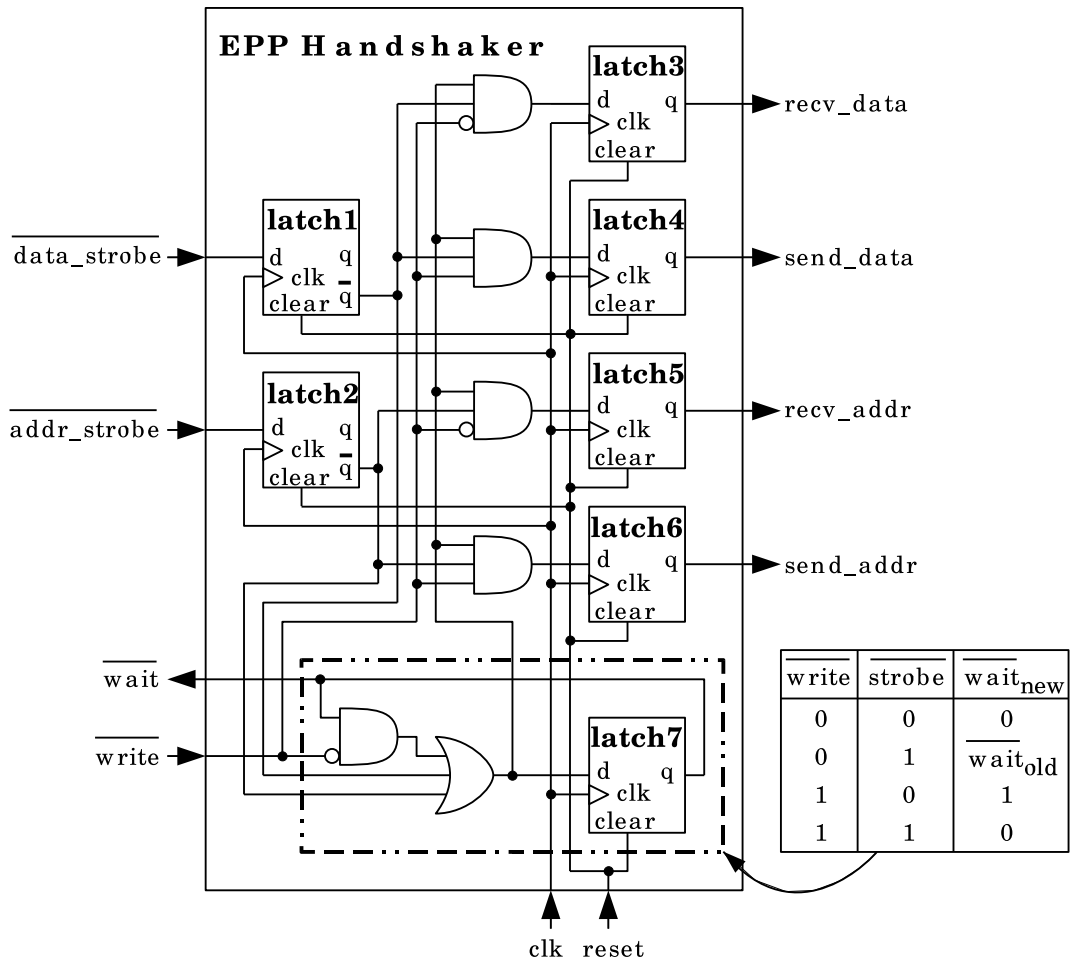


Figure 3.4: The EPP Handshaker

I/O transaction has been requested, and to signal the period during which the `data` signal should be valid. The `send_data` and `send_addr` outputs indicate when the FPGA should drive a data byte or the interrupt mask onto the shared `data` lines, respectively, and the `recv_data` and `recv_addr` signals respectively indicate when a data or address byte should be read from the `data` lines. Data are expected to be latched to or from the `data` lines on the rising edges of these signals, in accord with the diagram of the standard EPP I/O cycles. In the case of FPGA data-read and address-read transactions, the corresponding source of the requested data-byte is expected to drive the `data` lines while the associated `send_data` or `send_addr` signal is asserted.

The EPP address register

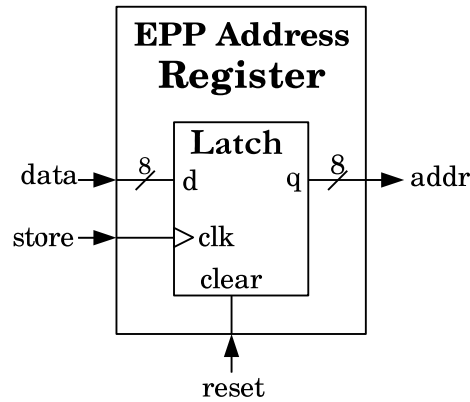


Figure 3.5: The EPP Address Register

The *EPP Address Register*, as shown in figure 3.5, holds the address of the data register that should be written to, or read from, by subsequent EPP data-write and data-read cycles. It is implemented as a simple octal latch which latches in the contents of the `data` lines on the rising edge of the `store` input signal. Note that the `store` input signal is driven by the `recv_addr` output of the *EPP Handshaker*. Thus the data-byte of each EPP address-write transaction ends up in this register. The `addr` output is the index of the addressed data register, and is thus connected to the `addr` input of the *EPP Register Bank* module.

The EPP Register Bank

The *EPP Register Bank*, as shown in figure 3.6, contains the registers that are used to record and provide read-back of configuration and command opcodes sent by the CPU. The `addr` input, which comes from the *EPP Address Register* module, selects which register should latch data from the `data` lines when the `recv` input goes high, or which register should drive its value onto the `data` lines, while the `send` signal is high. Register selection is implemented

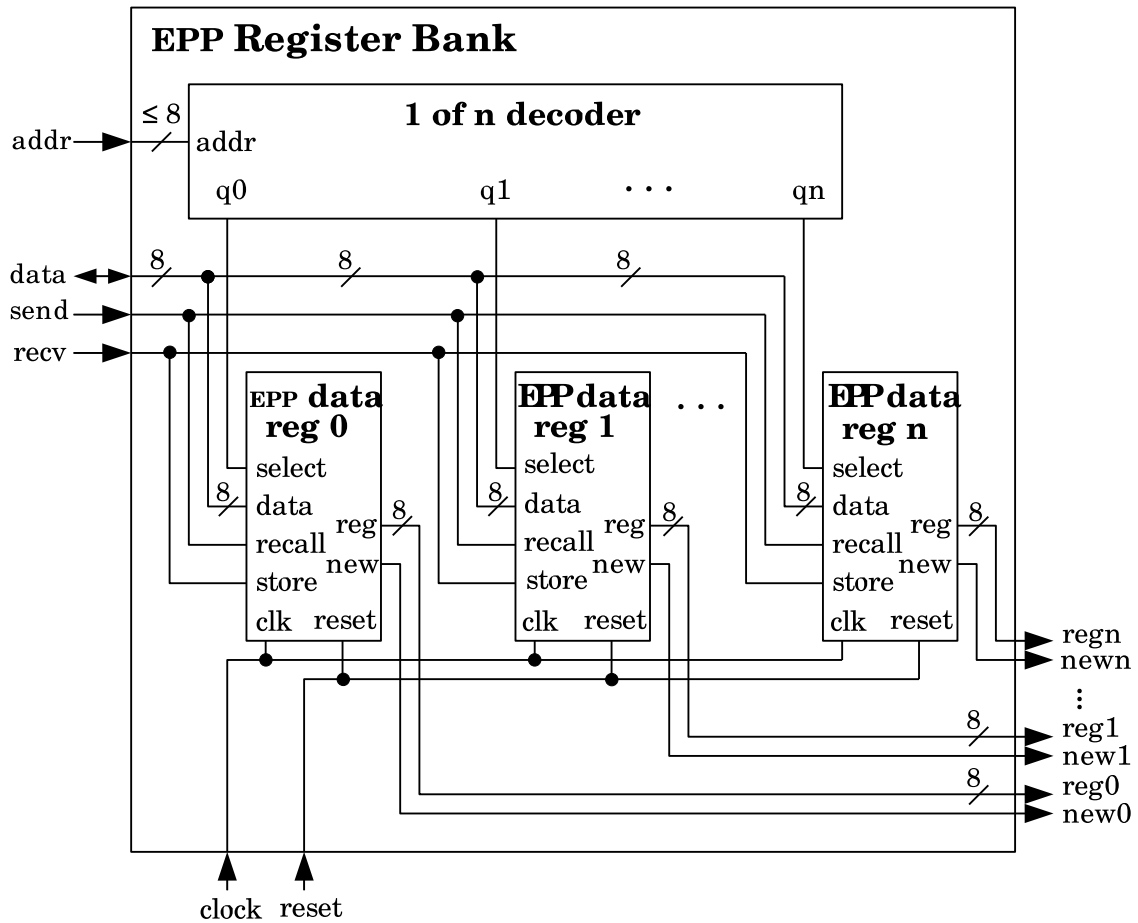


Figure 3.6: The EPP Register Bank

via an conventional address decoder, which asserts its i 'th q output when the address has the value i . Although the `addr` input provides an 8-bit address, which allows up to 256 registers; in practice much fewer registers will be needed, so a smaller decoder that ignores some of the most significant bits, can be used.

The individual data registers are implemented as *EPP Data Register* modules, implemented as shown in figure 3.7. Since only one register at a time can be addressed by EPP data-read and data-write cycles, each data register ignores its `store` and `recall` signal inputs except when its `select` input is asserted. When both this and the `recall` signal are high, the embedded octal register drives its current value onto the `data` lines, via a tri-state buffer. Alternatively, when the `select` signal is asserted, and the `store` input signal goes high, it does 2 things. First the rising edge of this signal causes the byte on the `data` lines to be latched into the embedded register. Then one clock cycle later, after the register has settled, latches 2 and 3 generate a single pulse, one clock-cycle in length at the `note` output. Thus the `note` output of each EPP data register is used to signal other parts of the firmware when it has been updated. For example, the FIFO which queues integration-specific configuration data will use this to shift each new value of the configuration register into the FIFO. Similarly registers that are to be interpreted as command opcodes will use this signal to trigger a command, without the opcode value within the register needing to change.

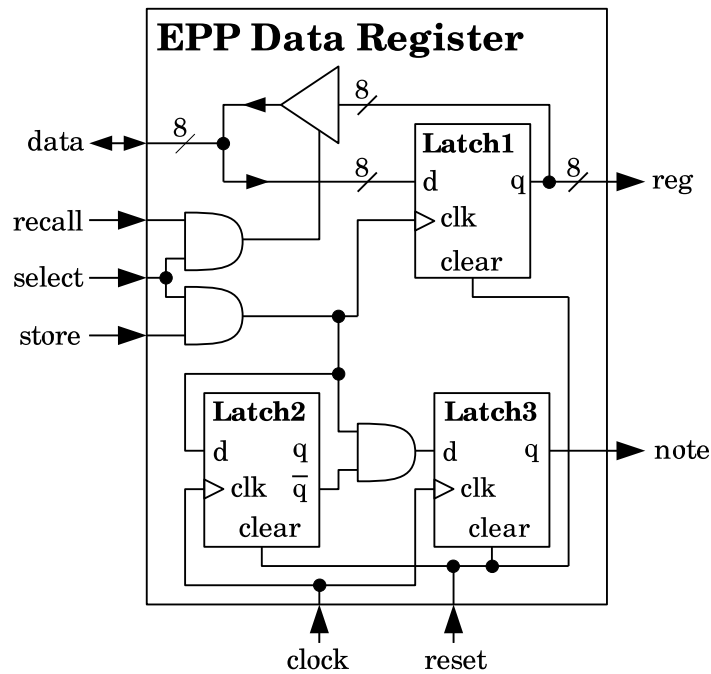


Figure 3.7: An EPP Data Register

The EPP Interrupter

The implementation of the *EPP Interrupter* module is shown in figure 3.8.

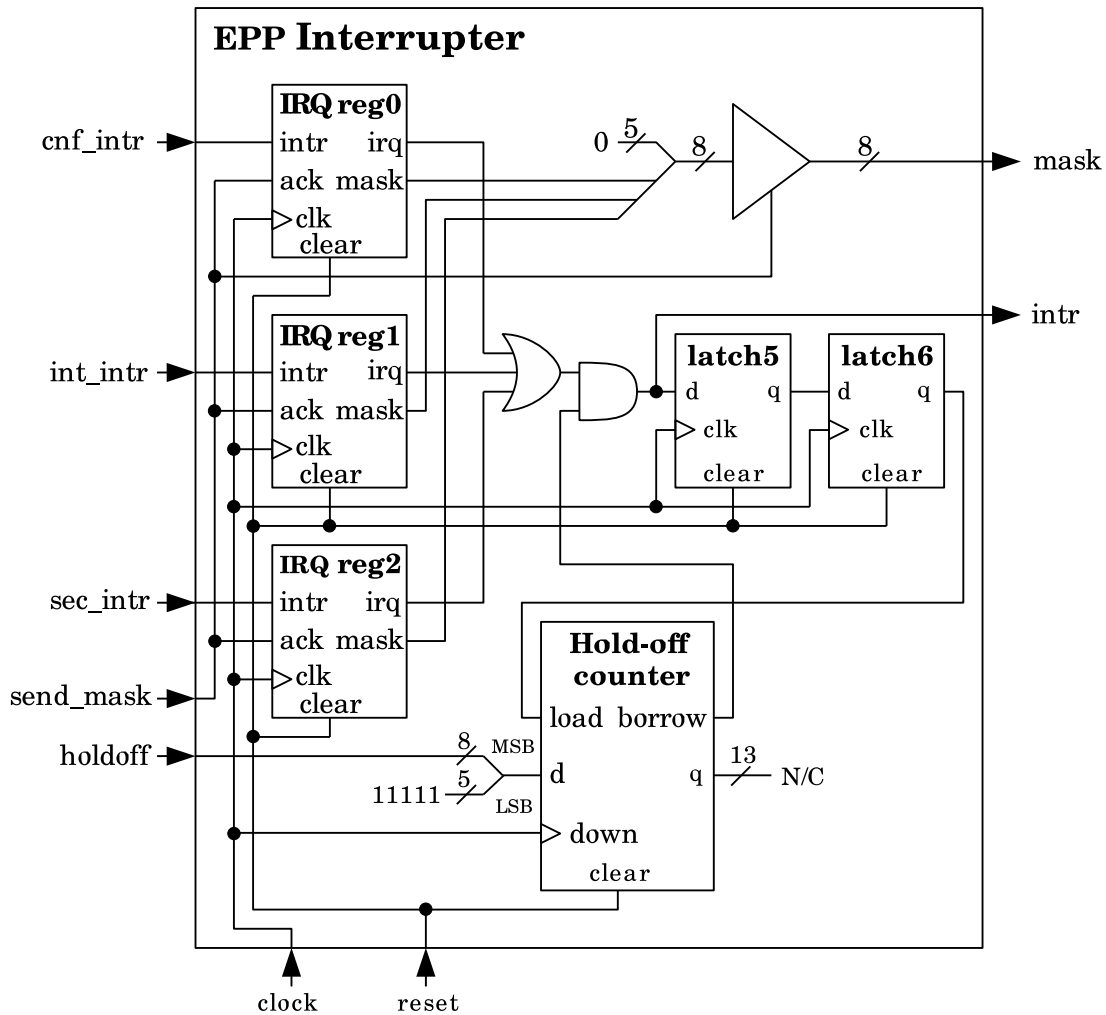


Figure 3.8: The EPP Interrupter module

As explained shortly, the CCB FPGA has three sources of interrupt-worthy events, all of which share the single parallel-port interrupt line (*intr*), under the auspices of the *EPP Interrupter* module. As such, the receipt of a parallel-port interrupt by the computer does not necessarily imply the occurrence of any particular new event in the FPGA. What it does tell the computer is that it should perform an EPP address-read to find out which events have occurred since the last time that it performed such a read. The resulting loose association between individual events and parallel-port interrupts, reduces the number of interrupts that the CPU has to handle, and allows a repeat interrupt to be sent if the computer appears to have missed the previous one, without any danger of the computer

incorrectly believing that a repeated interrupt represents a new event. Similarly, the only harm that spurious interrupts can do is bog-down the CPU, since the bit-mask of events returned by the subsequent EPP address-read, after a bogus interrupt, will indicate that nothing has really happened.

Interrupts are sent to the CPU at most once every `holdoff` clock cycles. In particular, once any interrupt source has requested an interrupt, a new CPU interrupt is sent every `holdoff` clock cycles, until the computer performs an EPP address-read to get the bit-mask of which event sources have requested interrupts.

When a particular event-source in the FPGA wishes to notify the computer of a new event, it asserts the associated one of the `cnf_intr`, `int_intr` or `sec_intr` interrupt-request inputs of the *EPP Interrupter* for at least one clock cycle. On the following clock cycle, the corresponding IRQ (interrupt-request) register becomes asserted, and remains asserted until the computer next performs an EPP address-read to query which event-sources have requested interrupts.

The *EPP Interrupter* examines the `irq` outputs of the IRQ registers at the start of each clock cycle, and if any of them are asserted, and the hold-off counter isn't still counting down from the previously sent interrupt, it raises the parallel-port `intr` signal to interrupt the CPU, and holds this signal high for two FPGA clock cycle (ie. 1.6 EPP 8MHz clock cycles). Simultaneously, it reloads the hold-off down-counter with the number of clock cycles that it should hold-off the generation of the next interrupt.

When the computer responds to the receipt of an interrupt, by performing an EPP address-read, the rising edge of the `send_mask` input latches the states of the IRQ registers to their respective `mask` outputs, which are then driven onto the parallel-port `data` lines via the tri-state buffered `mask` output of the *EPP Interrupter*. One clock cycle later, all of the IRQ registers whose latched `mask` outputs are asserted, are de-asserted, ready to register a new event. Note that the `mask` outputs remain unchanged when the register is de-asserted, since they must continue to drive the `data` lines until the `send_mask` input goes low.

Note that if an event-source requests a new interrupt while its IRQ register is still asserted from a previous unacknowledged request, the new request is lost. A way to prevent such losses would be to implement the IRQ registers using up/down counters. New interrupt requests would increment these counters, and acknowledgements would decrement them. The first iteration of this design, did just that. However, interrupts generally represent events that require a response while the interrupting event is still relevant, so queuing outdated interrupts is pointless. Furthermore, anytime that EPP interrupts were disabled, the CCB would quickly queue hundreds of unacknowledged events, which would then keep the CPU busy for a while acknowledging stale events, after interrupts were re-enabled. For these reasons, the idea of using up/down counters was abandoned, and it was decided that it made more sense to simply design the event-sources and the device driver around a limitation of one queued event per interrupt source, per EPP address-read.

Figure 3.9, shows the internals of a single IRQ register.

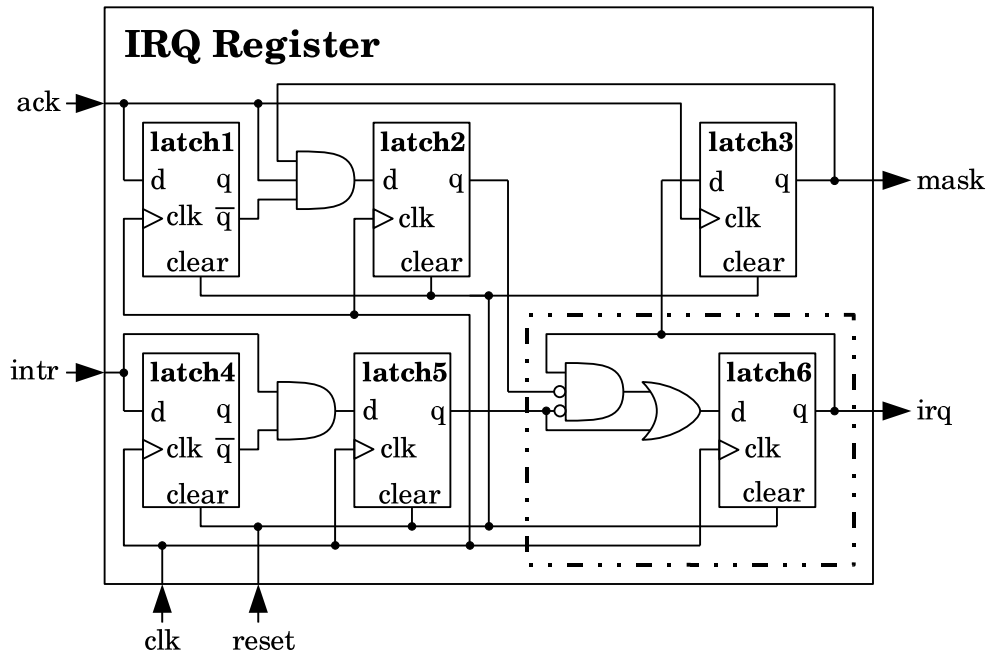


Figure 3.9: An Interrupt Request (IRQ) Register

The part of the circuit in the bottom right of the diagram, enclosed in a dashed box, is the IRQ register itself. It takes interrupt requests from the output of latch 5, and interrupt acknowledgements from the output of latch 2. An asserted interrupt-request input causes the `irq` output to go high, and thereafter stay high until the interrupt acknowledgement input is next asserted. If both a new interrupt request and an acknowledgement signal arrive on the same clock cycle, the new interrupt request takes precedence, and asserts the `irq` output. The value of the `irq` output is latched to the `mask` output, on the rising edge of the `ack` signal, ready to be driven onto one of the EPP data lines by a tri-state buffer in the parent *EPP Interrupter*.

The purpose of latches 4 and 5 is to generate a single pulse, one clock cycle in length, each time that the `intr` input goes high, regardless of how long the input signal remains high. This is needed to avoid a race condition with the acknowledgement signal. The rising edge of the single-cycle pulse actually occurs one clock cycle after the `intr` signal first goes high.

Similarly, the purpose of latches 1 and 2, is to convert a potentially multi-cycle pulse at the `ack` input into a single-cycle pulse at the acknowledgement input of the dashed circuit. In this case however, the one cycle delay in the initiation of this pulse, and an extra input to the AND gate, are exploited to ensure that the delayed acknowledgement input to the dashed circuit is not generated at all, unless the interrupt mask bit that was latched to the `mask` output, one clock cycle earlier, is high. In other words the IRQ register isn't actively de-asserted by an acknowledgement signal, unless it was asserted when its value was reported

to the computer. This guarantees that the `mask` output can be trusted to always report if at least one interrupt request occurred since the last time that the `mask` was latched. If, instead, the `IRQ` register were de-asserted without regard for whether an interrupt event had been reported to the computer, then any interrupt request that arrived at the `d` input of latch 6, on the same clock edge that latched the corresponding `q` output into latch 3, would get discarded by the `ack` signal one cycle later, and the event would never be reported to the computer.

The three interrupt sources that are envisaged at this point, are the following:

- `cnf_intr` - Integration configuration interrupts.

Before the start of each new integration, the *State Generator* needs to know the desired on/off states of the cal-diodes. In principle this could be sent one integration in advance, from an end-of-integration interrupt handler. That was the original plan. However, to soften the real-time requirements placed on the device driver in the CCB embedded computer, and thereby make the CCB insensitive to occasional transient anomalies in Linux's interrupt latency, the current plan is to instead implement a FIFO containing the configurations of many integrations in advance, instead of just one. Keeping this FIFO filled is the job of the `cnf_intr` interrupt. At the start of a scan, to fill the FIFO, multiple `cnf_intr` interrupts are generated, each one telling the computer to send the configuration of the next un-configured integration. Thereafter at the start of each new integration, one entry is removed from the FIFO, and a new entry is requested by sending another `cnf_intr` interrupt.

The rapid-fire `cnf_intr` interrupts at the start of a scan are rate-limited in two ways. First, a new `cnf_intr` input-signal is never raised by the *State Generator* until the CPU responds to the previous one by sending a new cal-diode configuration entry. Secondly, the `holdoff` timer of the *EPP Interrupter* sets a hard limit on the parallel-port interrupt rate, regardless of how quickly the CPU responds.

- `int_intr` - Integration-done interrupts.

Integration-done interrupts are generated when one integration ends and another starts. If a new integration starts before the interrupt from the start of the previous integration has been acknowledged by the computer, the new interrupt request is simply discarded, but the previous integration request continues to generate retry interrupts at intervals controlled by the `holdoff` timer. Thus the CCB device driver should not count integration interrupts to determine how many integrations have been completed at a given time, and nor should it use this interrupt for anything that absolutely has to be performed within a small time frame following the boundary between 2 integrations.

As mentioned in the discussion of the `cnf_intr` input, originally integration-done interrupts were needed for sending cal-diode configurations one integration at a time. It isn't clear yet whether this event will be useful for anything else in the device driver,

so for the moment, it is included here mostly as a placeholder, and may end up being removed.

- `sec_intr` - 1 second interrupts.

A `sec_intr` interrupt is requested once per second, at the rising edge of the second FPGA clock cycle that follows the rising edge of the pulse of the external 1PPS signal (to avoid metastable latch states). Like the integration interrupt, if a previous 1-second interrupt hasn't been acknowledged by the time that a new one is to be generated, the new one is simply ignored, while the *EPP interrupter* continues to retry sending the original. Given the length of time between these interrupts, this should only happen when the CCB device driver isn't loaded, or if either the parallel cable or the computer are damaged.

By default, at boot time, EPP interrupts are disabled, and a write to the parallel-port configuration register is needed to enable them. While they are disabled, signals on the `intr` interrupt line are simply ignored by the computer. Thus the FPGA doesn't redundantly provide its own way to enable and disable the generation of interrupt signals on the `intr` line. Note that the resending of unacknowledged interrupts every `holdoff` clock-cycles, ensures that interrupts that are missed while the parallel-port has interrupts disabled, get re-sent and acknowledged as soon as interrupts become enabled.

3.2 The Data Dispatcher

At the end of each integration period, and at the start of dump mode, the *Data Dispatcher* component reads integrated or dump-mode data from the slave FPGAs into a large FIFO, then streams the contents of this FIFO, preceded by a header, to the computer, via the USB bus. All communications over the USB bus are directed from the FPGA to the computer. Thus, although the read (`rd`) and read-enable (`rxif`) pins of the USB interface are shown as inputs to the *Data Dispatcher*, there are no plans to use them at the moment.

Note the use of the DLP-USB245M module. This is a tiny PCB module containing a 6MHz crystal, a surface-mount FT245BM USB1.1 chip, a USB connector and all the interconnections needed between these parts. The PCB is just 1.5×0.7 inches in size, and the USB connector sticks out a further third of an inch from one end. The module can be soldered onto the CCB PCB, via 24 dual in-line pins. Its data-sheet can be downloaded from:

<http://www.dlpdesign.com/usb/dlp-usb245m12.pdf>

The two of these modules that I bought for testing the FT245BM, I got from a company called Saelig (www.saelig.com), which is an official US distributor for the FT245BM. The

modules arrived overnight. Since then, I have noticed that Mouser Electronics carries them as well. Their catalog number at Mouser is 626-DLP-USB245M, and they cost \$25.

3.2.1 The internals of the Data Dispatcher

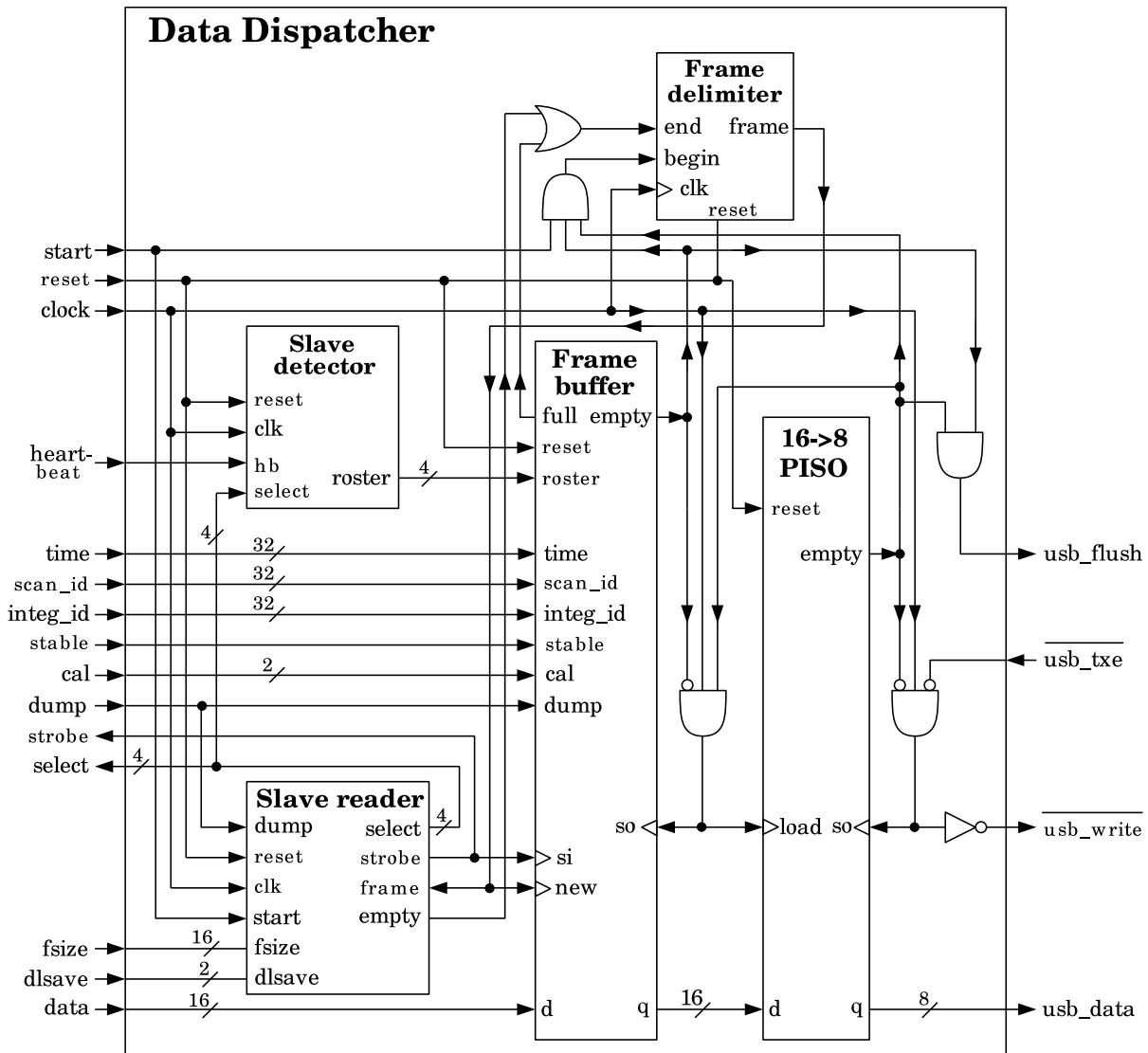


Figure 3.10: The Data Dispatcher

Figure 3.10 shows the building blocks of the *Data Dispatcher*, and how they are interconnected. The *Slave Reader* selects one slave at a time, via its `select` outputs, and reads-out all of its available data before going on to read from the next slave. The data that are read out from each slave, appear on the shared slave data-lines, which deliver them to a FIFO in

the *Frame Buffer*.

In normal integration mode, the *Slave Reader* cycles through the slaves in reverse numerical order. In dump-mode it persistently selects data readout from the slave that is specified by the `ds_lave` input signal.

The `frame` output signal of the *Frame Delimiter* controls the packaging of output data frames within the *Frame Buffer*. When the `frame` signal goes high, a new output data-frame is initialized, and data from the slaves start to be transferred to the *Frame Buffer*. When all data from the slaves have been transferred, or the frame-buffer becomes full, the `frame` signal goes low, to terminate the frame. The `frame` signal doesn't go high again until the next rising edge of the `start` signal from the `start_snd` output of the *State Generator*, and even then, it only goes high if the previous contents of the *Frame Buffer* have been completely transferred to the CPU over the USB link. These measures prevent a new frame from trampling on an incompletely sent frame, and when in dump mode, prevent temporary buffer-full conditions creating sporadic sampling gaps within a frame.

The *Frame Buffer* contains a large FIFO for the slave data, plus a small PISO in which the frame header is assembled. The frame header, which is flash loaded into the PISO, on the rising edge of the `frame` signal, consists of a time-stamp, a scan sequence number, an integration sequence number, a roster of functioning slave FPGAs, an integration flag-bit, the states of the cal-diodes during the just-completed integration, and frame-start and dump-mode indicators.

Once a new frame has been started, the contents of the *Frame Buffer* are clocked out, 16-bits at a time, starting with the frame header in the PISO, and followed by the slave data from the FIFO. Each 16-bit chunk is loaded into a 2 entry, 8-bit wide PISO, such that 8-bits at a time can then be clocked out to the 8-bit FIFO in the USB chip, whenever the USB chip has space. When both the *Frame Buffer* and the latter 8-bit PISO have been emptied of all data, the `usb_flush` signal is asserted, to tell the USB chip to send all remaining data to the CPU, as soon as possible, without waiting for enough data to precisely fill up the final USB block.

The internals of the Frame Delimiter

The implementation of the *Frame Delimiter* is shown in figure 3.11.

When the `end` input signal is asserted at the start of a clock cycle, the `frame` output becomes de-asserted, regardless of the state of the `begin` input signal. This terminates the assembly of an output frame. The `frame` signal does not go high again, until the start of a clock cycle when the `begin` signal is newly asserted, after the `end` signal has been de-asserted.

This means that a new frame will not begin if the `begin` signal is asserted while the `end` signal is still asserted, and that if the `end` signal becomes asserted during a frame, the frame

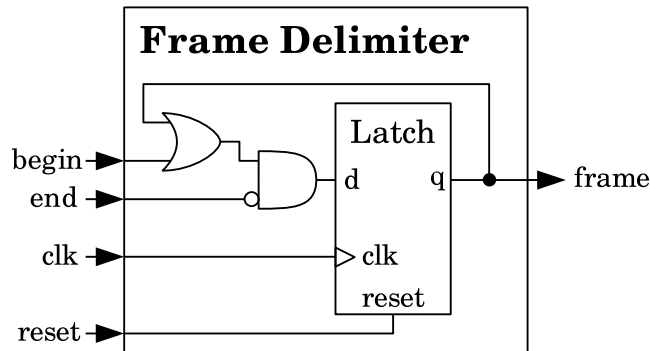


Figure 3.11: The Frame Delimiter

is considered to be complete, regardless of the state of the `begin` input.

The internals of the Slave Reader

The implementation of the *Slave Reader* is shown in figure 3.12.

The *Slave Reader* selects which slave is to be read from on the next clock cycle, outputs the strobe that tells the currently selected slave to present the next unread 16-bit sample for readout, and tells the *Frame Delimiter* when all available samples have been read from all pertinent slaves.

In particular, in normal integration mode, the *Slave Reader* arranges that all data from slave 3 be read out first, followed by all data from slave 2, then all data from slave 1 and finally all data from slave 0. Alternatively, in dump mode, it indicates that data should only be read from the slave that is indicated by its `dslave` input. In both of these cases, once a total of `fsize` samples have been read-out, since the start of the frame, *Slave Reader* asserts its `empty` output signal, to indicate to the *Frame Delimiter* that readout should stop. In normal integration mode, the *State Generator* thus sets the `fsize` input such that all of the slave PISOs are emptied before the *Slave Reader* asserts the `empty` signal, whereas in dump mode, it sets the `fsize` input according to the currently configured size of a dump-mode frame.

As evident in the diagram, the major functionality of the *Slave Reader* is implemented using a down-counter. This is preset to the value of the `fsize` input at the start of a new frame, when the `start` input is asserted. One clock-cycle later the output of the counter has settled to this value, and the *Data Dispatcher* reads the first sample from the specified slave, and the down-counter decrements by one, before the next sample is read on the next clock-cycle. The actual number of samples that get read before the asserted `borrow` output prevents further readout, is `fsize + 1`. Therefore the value of `fsize` actually represents one less than

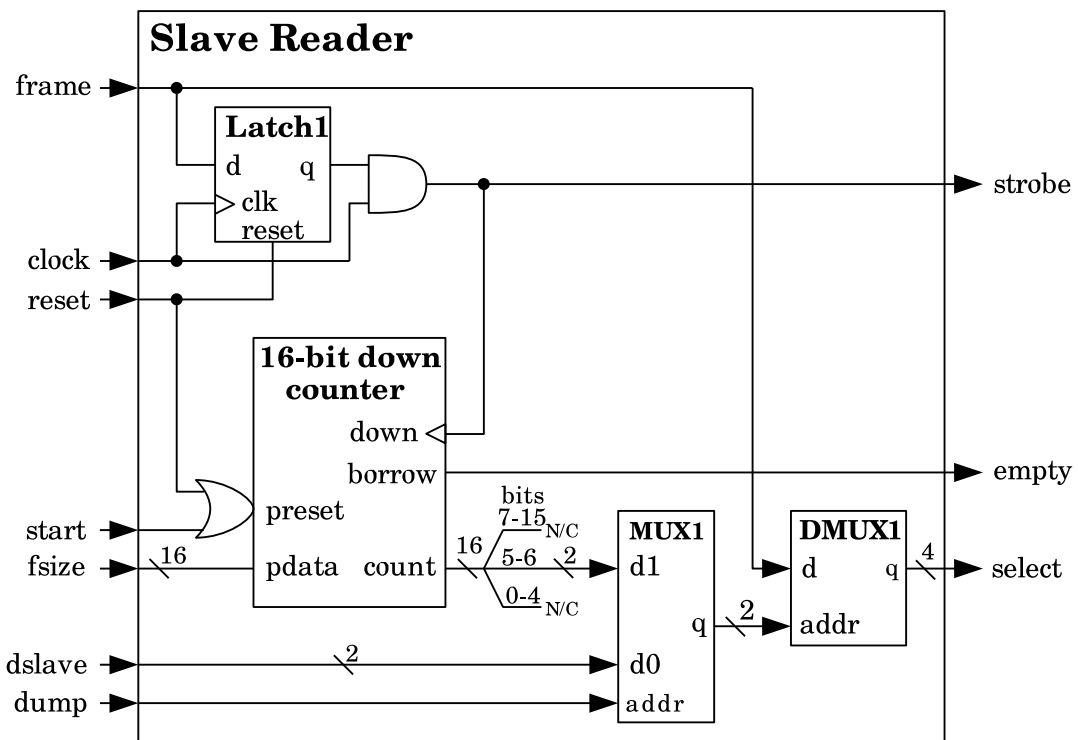


Figure 3.12: The Slave Reader

the number of samples that are to be read from the slaves.

In normal integration mode, bits 5 and 6 of the output count (counting bits from 0), are used to specify the slave that is to be read from. In this mode, these are the two most significant bits of the count, because in normal integration mode, the *State Generator* sets `fsize` to 127 (ie. $32\text{PISO entries} \times 4\text{slaves} - 1$). Thus for the first 32 clock cycles, the two msb's of the count set the `slave` output to 3, then for the next 32 clock cycles they set `slave` to 2, then 1, then finally 0. In this way 32 samples are read from each slave, one slave at a time, starting with slave 3, and ending with slave 0.

Currently it isn't known how much space can be allocated for the FIFO in the *Frame Buffer*, so the maximum frame size is similarly unknown. As such, the `fsize` input has been arbitrarily assigned 16 bits, for now, which corresponds to a maximum size of a dump-mode frame of 65536 contiguous ADC samples (6.5ms). The actual size of the `fsize` input can be better tuned to the size of the FIFO obtained, when the design is complete, but in practice there is no harm in it being bigger than the available space in the FIFO, since the *Data Dispatcher* keeps an eye on the state of the *Frame Buffer* and terminates the frame early, as soon as the *Frame Buffer* becomes full.

The `strobe` output is pulsed as each sample is read-out, and a new sample should be presented by the currently selected slave. Now when the slaves receive the `start` signal, at the end of an integration, the outputs of the slave PISOs become valid on the second rising clock-edge following this. The *Slave Reader* must not attempt to read the first sample until this time. Since the `frame` input signal goes high one clock cycle after the `start` signal, the *Slave Reader* thus needs to generate the initial `strobe` pulse one clock cycle after the `frame` input goes high. This is the function of `Latch1`, whose `d` output goes high one clock cycle after the `frame` input goes high. Note that the `select` signal doesn't have this additional delay, since it needs to go high one clock cycle before the first `strobe` pulse, in order that the initial sample of the PISO be driven onto the data lines, and have time to settle, before the first `strobe` signal, when it is read out, and then replaced by the second sample.

The internals of the Frame Buffer

As shown in figure 3.13, the *Frame Buffer* has two major parts, a 16-bit wide PISO containing a frame header, and a large 16-bit wide FIFO containing integrated or dump-mode data. The outputs of the *Frame Buffer* simulate the output of a virtual 16-bit wide FIFO, formed from the serialized concatenation of the contents of these two parts, with the header coming out first, followed by the data.

The glue-logic with which the Data Dispatcher embeds the *Frame Buffer*, ensures that a new frame can not be started unless the *Frame Buffer* is empty. Thus whenever a new frame is successfully started, it is guaranteed that both the data FIFO and the header PISO of the *Frame Buffer* are empty. The start of a new frame is signaled by a rising edge on the `new` input, which is externally connected to the `frame` output of the *Frame Delimiter* in the Data

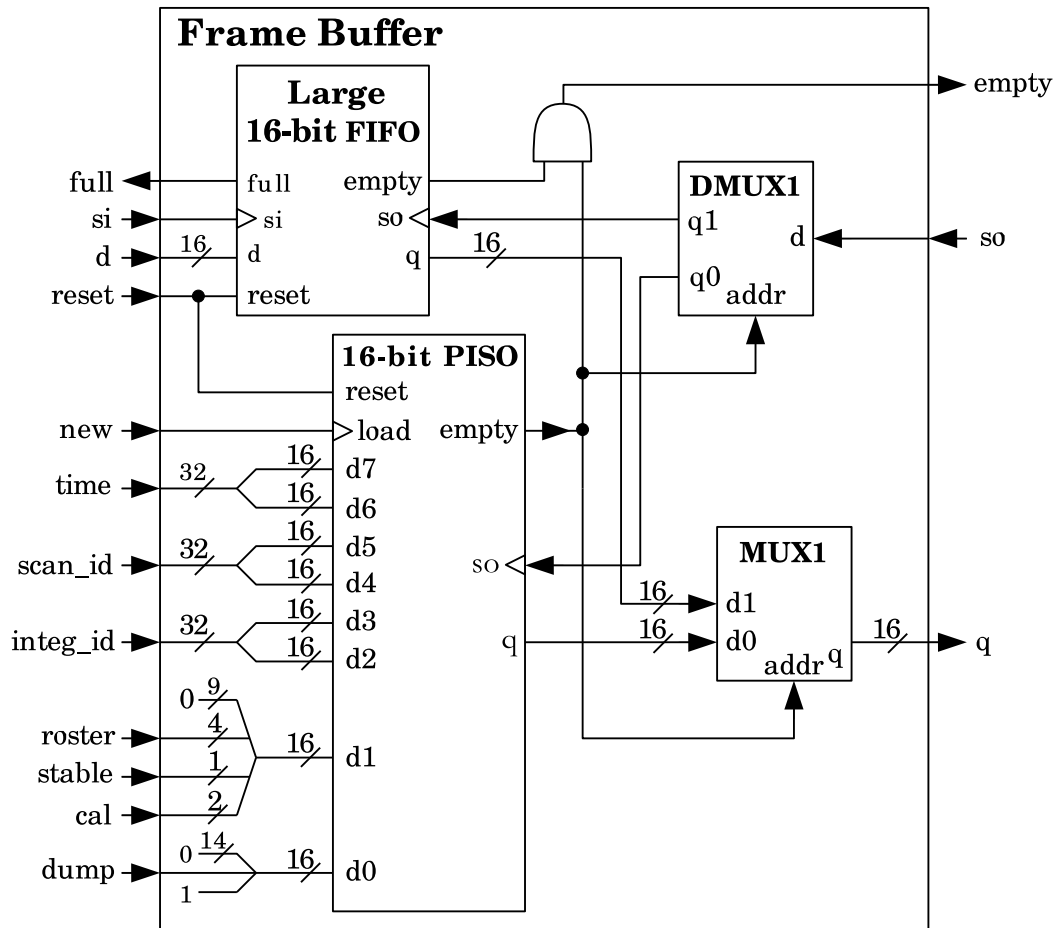


Figure 3.13: The Frame Buffer

Dispatcher.

At the start of a new frame, the rising edge of the `new` input-signal causes the header PISO to load the contents of the header, as derived from input signals received from the *State Generator*. The header currently consists of 8 16-bit words, which are as follows.

- The first of the 16-bit header words identifies the type of frame that is being packaged, and since it has a value that doesn't look like a data value, the CPU can use it as the indication of the start of a new frame, in case other frame separation measures don't work.

Note that a normal data value will either be zero, in the case of a missing ADC board, or be a significantly non-zero number, in the presence of sampled noise. So a small non-zero 16-bit number, is a good choice for something that should not look like a data sample.

Thus to ensure that the first header-word not look like a data sample, its 16-bit value is always a small non-zero number, having either the value 1 or the value 3. A value of 1 signifies that the frame is a normal integration frame, whereas a value of 3 means that it is a dump-mode frame.

- The second of the header words is a 16-bit word indicating various conditions that pertained while the data were being taken. Bits 0 and 1 report the commanded states of the cal-diode switches during the integration. Bit 2 tells the CCB manager that the phase and/or cal-diode switches were stable throughout the integration. Bits 3 through 6 is a boolean list of the slave FPGAs whose heartbeat signals indicate that they are present and functioning. The remaining 9 bits are unused.
- The 3rd and 4th header words are the least and most significant 16 bits of a 32-bit number, which specifies the sequential number of the integration within its parent scan, starting from zero for the first integration of a new scan, and incrementing by one each time that a new integration starts.
- The 5th and 6th of the header words are the least and most significant 16-bits of the 32-bit number which identifies the parent scan, according to the number of new scans (and intra-scans) that had been requested when the parent scan was commanded. Whenever the CCB firmware is reset, the scan-counter is reset to zero.
- Finally, the 7th and 8th header words are the least and most significant 16 bits of a 32-bit time-stamp. This is the value of a counter in the *State Generator* which is reset to zero at the start of each new scan, and incremented by 1 every clock cycle thereafter. Thus the time-stamp measures the time elapsed since the start of the second on which the last scan started, has a resolution of 100ns, and wraps around every 430 seconds.

On the real-time computer, the sum of the absolute time of the 1PPS edge on which the scan was started, and the above relative time-stamp (after accounting for wraparounds), will form the high-resolution time-stamp that is sent with the data, to the manager.

On the same clock edge during which the **new** signal goes high, data become available from the slaves. These data are synchronously clocked into the FIFO, 16-bits at a time, by the *Data Dispatcher*, using the **si**, shift-in, input and the **d**, data inputs. This continues until there are no data left to be read from the slaves, or the FIFO becomes full. In either case, the *Frame Delimiter* then disables further input to the *Frame Buffer*, until the next time that the *State Generator* asserts the **start** signal, after the contents of the *Frame Buffer* have all been sent to the real-time CPU.

The internals of the Slave Detector

The *Slave Detector* module attempts to determine whether each of the slave FPGAs are present and functional, by monitoring their heartbeat signals. Each slave emits a single-bit heartbeat signal which changes state at the start of each new clock cycle. The job of the *Slave Detector* is thus to verify that each of the heartbeat signals switches state from one clock cycle to the next. The implementation is shown in figure 3.14.

As can be seen, each slave has its own *Heartbeat Detector* module, which is enabled when the slave is selected for readout by the *Slave Reader*. At the end of each integration the 4 **alive** outputs of the *Heartbeat Detectors*, combined into the 4-bit **roster** output provide an indication of which slaves were alive during the integration period.

The internals of the Heartbeat Detector modules

The implementation of the individual *Heartbeat Detector* modules is shown in figure 3.15.

While the output of **Latch2** holds the state of the slave's heartbeat signal from the most recent rising edge of the clock, the output of **Latch3** does the same for the clock cycle that preceded this. The two latch outputs should thus be complements of each other if the slave is present and generating a valid heartbeat signal, that toggles state at the start of each clock cycle. If the slave is missing, or isn't generating a heartbeat signal, then the two latch output bits will be identical, and the output of the exclusive OR gate stays low.

The combination of **Latch 1** and the adjacent AND gate cause the the module to sample the heartbeat signal at the start of each clock cycle while the **select** signal is asserted, starting from the clock cycle that follows the select signal going high, and ending on the clock cycle that precedes the **select** signal going low again. The start and end conditions ensure that the heartbeat signals from the previously selected and next to be selected slaves, aren't incorrectly mixed in.

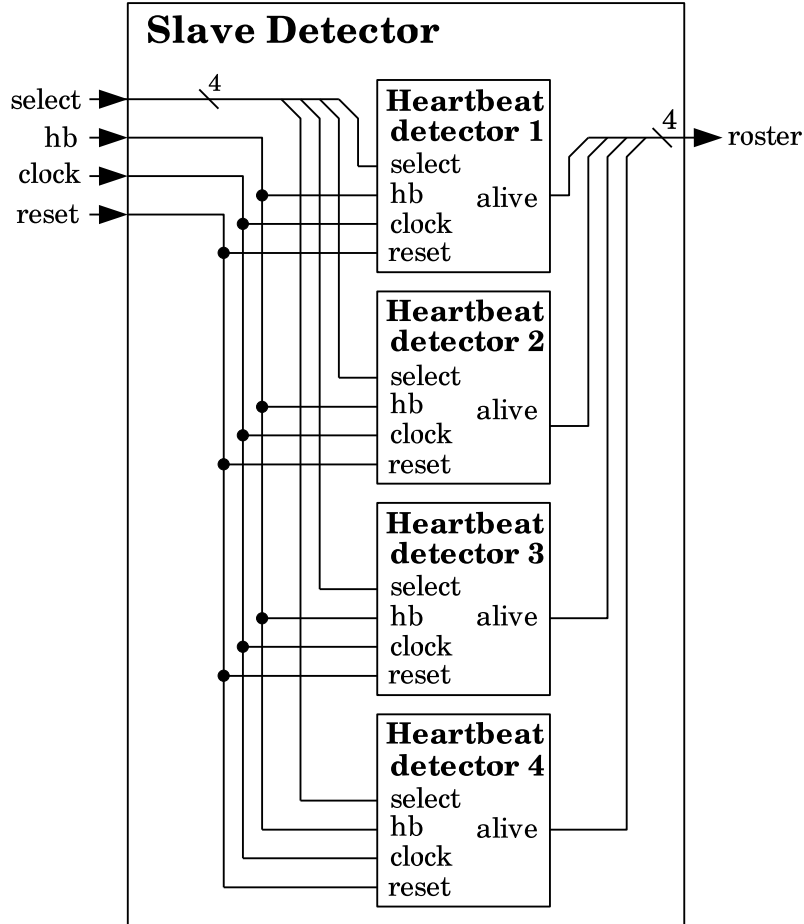


Figure 3.14: The Slave Detector

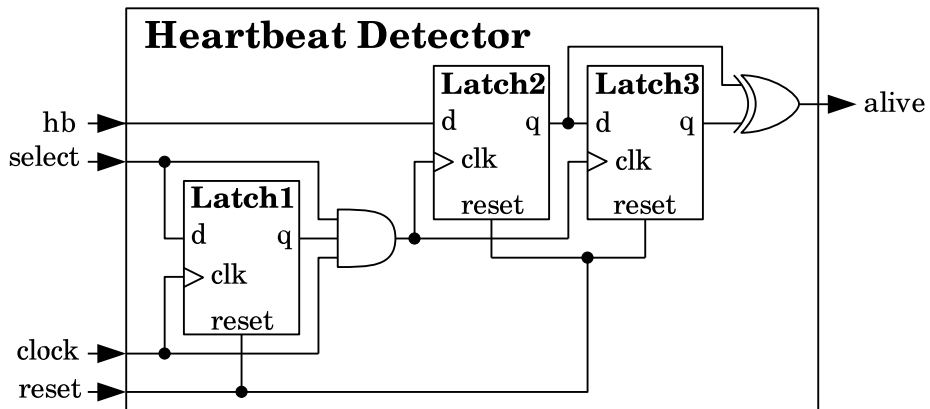


Figure 3.15: The Heartbeat Detector

3.3 The State Generator

3.3.1 Registers

As previously documented, the *Control Gateway* manages an array of 8-bit registers that the computer can read and write via its parallel port. These registers are also visible to the *State Generator*, which can interpret their contents however it wishes, and the *State Generator* is informed, by the *Control Gateway*, whenever a given register is written to by the computer, via a per-register transient flag. In practice the *State Generator* divides its interpretation of the registers into two distinct classes.

- **Action registers**

When an action register is written to by the computer, the *State Generator* immediately does something in response. An example is the register whose value tells the FPGA to start a new scan or intra-scan.

- **Configuration registers**

When a configuration register is written to, the only thing that happens immediately is that the new value is stored within the register bank of the *Control Gateway* for later use. The new value has no effect on the currently running scan or intra-scan. Subsequently, when a new scan or intra-scan is commanded, the updated values of these registers are copied into active configuration registers within the *State Generator*, and used to determine the behavior of the new scan. Thus, while configuration registers can be written to at any time, their new values only take affect when the next scan or intra-scan is initiated.

The list of action registers

- `start_scan_reg` – Start a new scan or intra-scan.

Whenever this register is written to by the computer, the *State Generator* first halts any existing scan, then, depending on the revised contents of the register, starts a new one, either immediately, or at the start of the next second.

The bit assignments of the register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
00	X	X	close_b	close_a	switch_b	switch_a	test	sync

The meanings of the bit-value names are:

- **sync**
If 0, start the new scan as quickly as possible. If 1, start the new scan at the next rising edge of the 1PPS signal.
 - **test**
If 0, use real ADC samples as the input to the CCB. If 1, use pseudo-random fake samples as the input to the CCB.
 - **switch_a**
If 0, phase-switch A should be held in the state specified by the `close_a` bit, for the duration of each phase-switch cycle. If 1, phase-switch A should be toggled on and off during each phase-switch cycle.
 - **switch_b**
If 0, phase-switch B should be held in the state specified by the `close_b` bit, for the duration of each phase-switch cycle. If 1, phase-switch B should be toggled on and off during each phase-switch cycle.
 - **close_a**
If 0, phase-switch A should be opened at the start of each phase-switch cycle. If 1, phase-switch A should be closed at the start of each phase-switch cycle.
 - **close_b**
If 0, phase-switch B should be opened at the start of each phase-switch cycle. If 1, phase-switch B should be closed at the start of each phase-switch cycle.
 - **X**
The value of this bit is currently unused, and should be assigned 0.
- **conf_integ_reg** – Queue a new integration configuration.

Append one entry to the queue of future integration configurations. This register is to be written to whenever the computer receives a `cnf_intr` interrupt. In particular, immediately after the computer writes to the `start_scan_reg` register, to initiate a new scan, the master FPGA generates a `cnf_intr` CPU-interrupt to ask the computer for the configuration of the first integration of the new scan. The first integration of the scan can not proceed until this information has been received. The second time that a `cnf_intr` interrupt is received by the computer, after initiating a new scan, the configuration of the second integration of the scan should be written to the `conf_integ_reg` register, and so on. Since the receipt of a `cnf_intr` interrupt is the only race-condition-free way that the computer can reliably know when there is space for a new configuration byte within the queue of integration configurations, the computer must not write to the `conf_integ_reg` register at any other time.

The configuration bits within the `conf_integ_reg` register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
01	X	X	X	X	X	X	diode_b	diode_a

Where the meanings of the bit-value names are:

- **diode_a**
If 0, calibration diode A should be commanded off at the start of the target integration. If 1, calibration diode A should be commanded on at the start of the target integration.
- **diode_b**
If 0, calibration diode B should be commanded off at the start of the target integration. If 1, calibration diode B should be commanded on at the start of the target integration.
- **X**
The value of this bit is currently unused, and should be assigned 0.

The list of configuration registers

- **phase_state_dt_reg** – The number of samples per phase-switch state.

This register specifies how long a single combination of phase-switches should last within a a phase-switch cycle. It is expressed as a number of 100ns ADC samples, and is a 16 bit number which extends across two 8-bit registers. It has minimum and maximum supported values of 250 and 65535, which correspond to durations of 25 μ s and 6.5ms.

The configuration bits within the **phase_state_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
02	b15	b14	b13	b12	b11	b10	b9	b8
03	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

- **b0..b15**
Bits 0 to 15 of the 16-bit number, with **b0** denoting the least significant bit, and **b15** denoting the most significant bit.
- **phase_switch_dt_reg** – The phase-switch settling time.

This register specifies how many 100ns ADC samples should be blanked to account for the settling time of the phase switches. The duration occupies a single 8-bit register, and thus allows for settling times of between 0 and 25.6 μ s.

The configuration bits within the **phase_switch_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
04	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b7**

Bits 0 to 7 of the 8-bit number, with b0 denoting the least significant bit, and b7 denoting the most significant bit.

- **diode_rise_dt_reg** – The rise-time of the cal diodes.

This register specifies how long it takes for the effects of turning a calibration diode on, to stabilize to below the limits of detectability. It is expressed as a number of 100ns ADC samples, and is a 32 bit number which extends across four 8-bit registers. The use of 32 bits establishes a maximum rise-time of about 7 minutes. This will hopefully be overkill, but the long duration allows for the potential that the diodes might need a significant amount of time to respond thermally to the change in loading when they are switched on.

The configuration bits within the **diode_rise_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
05	b31	b30	b29	b28	b27	b26	b25	b24
06	b23	b22	b21	b20	b19	b18	b17	b16
07	b15	b14	b13	b12	b11	b10	b9	b8
08	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b31**

Bits 0 to 31 of the 32-bit number, with b0 denoting the least significant bit, and b31 denoting the most significant bit.

- **diode_fall_dt_reg** – The fall-time of the cal diodes.

This register specifies how long it takes for the effects of turning off a calibration diode to stabilize to below the limits of detectability. It is expressed as a number of 100ns ADC samples, and is a 16 bit number which extends across two 8-bit registers. The use of 16 bits establishes a maximum diode fall-time of 6.6ms.

The configuration bits within the **diode_fall_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
9	b15	b14	b13	b12	b11	b10	b9	b8
10	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b15**

Bits 0 to 15 of the 16-bit number, with **b0** denoting the least significant bit, and **b15** denoting the most significant bit.

- **integ_period_reg** – The duration of an integration period.

This register specifies the duration of each integration, as a multiple of the currently configured phase-switch cycle duration. This is a 16 bit value, which extends across two 8-bit registers. Since phase-switch states are required to persist for no less than $25\mu\text{s}$, and up to 32 states are allowed per phase-switch cycle, the use of 16 bits establishes a minimum maximum of 52 seconds per integration. This far exceeds the roughly estimated 1 second duration at which a weak-signal would saturate the 32-bit integration accumulators.

The configuration bits within the **integ_period_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
11	b15	b14	b13	b12	b11	b10	b9	b8
12	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b15**

Bits 0 to 15 of the 16-bit number, with **b0** denoting the least significant bit, and **b15** denoting the most significant bit.

- **roundtrip_dt_reg** – The CCB/receiver roundtrip delay.

This register specifies an estimate of the length of time between the CCB toggling a switch control-signal, and the first effects of this operation being seen in the detected signal that arrives at the CCB. It should be on the short side of the actual estimated value, such that samples from when the switch began changing the signal, don't get incorrectly included with the pre-switch samples.

This is an 8-bit value, expressed as a multiple of the 100ns ADC sampling interval. The maximum supported roundtrip delay is thus $25.6\mu\text{s}$.

The configuration bits within the **roundtrip_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
13	b7	b6	b5	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b7**

Bits 0 to 7 of the 8-bit number, with b0 denoting the least significant bit, and b7 denoting the most significant bit.

- **holdoff_dt_reg** – The CCB/receiver roundtrip delay.

This register sets the maximum rate at which the CCB is allowed to generate interrupts, expressed as the minimum interval between interrupts. It is a 5-bit number which has 1 added to it, before being scaled by $25.6\mu\text{s}$, to arrive at the actual holdoff interval. Thus the range of supported holdoff intervals is $25.6\mu\text{s} \leftrightarrow 819.2\mu\text{s}$

The configuration bits within the **holdoff_dt_reg** register are as follows.

Register address	The value of each bit							
	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
14	X	X	X	b4	b3	b2	b1	b0

The meanings of the bit-value names are:

– **b0..b4**

Bits 0 to 4 of the 5-bit number, with b0 denoting the least significant bit, and b4 denoting the most significant bit.

– **X**

The value of this bit is currently unused, and should be assigned 0.

3.3.2 The 1PPS Gateway

The external GBT 1PPS signal is a train of $1\mu\text{s}$ pulses, with a period of 1 second, and an amplitude of 4V. Each pulse signals the start of a new second of UT. The job of the 1PPS gateway is to convert each $1\mu\text{s}$ pulse into a pulse whose rising edge coincides with a rising edge of the FPGA clock, and whose duration is a single FPGA clock cycle. The circuit shown in figure 3.16 does this.

Since the 1PPS input signal isn't synchronous with the FPGA clock, latch 1 is used both to synchronize the signal, and to allow one clock cycle for any metastable state in latch 1 to settle before latches 2 and 3 sample its output. Thus, one clock cycle after latch 1 latches the start of a new 1PPS pulse to its q output, latches 2 and 3 both latch a high value to their q outputs. On the following clock cycle, the \bar{q} output of latch 2 is low, so latch 3 latches

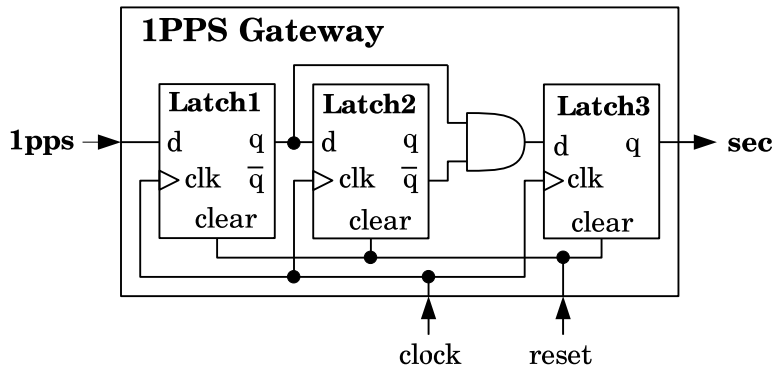


Figure 3.16: The 1PPS Gateway

a low value to its output. Thus latch 3's q output goes high for precisely one clock cycle, regardless of how much longer the external input pulse lasts. Clearly, the rising edge of latch 3 trails the rising edge of the external 1PPS signal by between one and 2 FPGA clock cycles. This translates to a maximum delay of $0.2\mu\text{s}$, which is an insignificantly small fraction of the CCB's 1ms minimum integration time.

3.3.3 Dealing with round-trip delays and settling times

A serious complication in the design of the *State Generator* is the fact that there are significant round-trip delays and finite settling times involved in controlling the cal-diodes and phase switches.

The round-trip delay

When any of the receiver control signals are toggled, the initial effect of this on the detected signal is not seen by the slave FPGAs for a few clock cycles. First of all the digital switching control-signals are delayed by the RFI filters, opto-isolators and cables that separate them from the receiver. In particular, opto-isolators generally have propagation delays of around 100ns, which corresponds to one FPGA clock cycle. Then if the switches start to respond as soon as the control signal finally arrives, the 8-pole 2MHz Bessel low-pass filter in the receiver, delays the perturbed signal by another 250ns, the 4-stage pipeline pipeline in the ADCs delays it by another 300ns, and the input latch in the slave FPGAs delay the use of the digitized signal by another 100ns. Thus, even if one only accounts for these known delays, and ignores all other possible sources of delays, such as the RFI filters, the detectors, and the phase-shift in the ADC clock signals, it is clear that there will be a delay of at least 750ns, or 7.5 clock cycles, between the master FPGA toggling a receiver control signal and the slave FPGAs seeing any resulting perturbation in the digitized signal. Henceforth

this delay will be referred to as the round-trip delay. The round-trip delay is assumed to be identical for all switching signals, and in practice, is configured as an integral number of clock cycles, via a single 8-bit configuration register.

Within the *State Generator*, the significant round-trip delay presents a challenge. Whereas the signals that it generates to control the phase switches and calibration diodes, can be sent to the receiver as they are generated, the corresponding control signals that are destined for the slave FPGAs and the *Data Dispatcher* must not be arrive at these modules until many clock cycles later, after the roundtrip delay has passed. It would require an impractical number of gates to implement this delay by delivering the slave and *Data Dispatcher* signals via variable-length shift-registers, clocked by the 10MHz system clock, since there are a lot of signals that would need to be delayed, and each signal would require a shift register of around 10 stages. Fortunately, only the **blank** signal actually potentially needs to change on every 100ns clock cycle, and the next smallest time step is the $\geq 25\mu\text{s}$ duration of a single phase-switch state, which is much greater than the anticipated $\approx 1\mu\text{s}$ roundtrip delay. A workable strategy is thus as follows.

1. Clock the the main state machine with the phase-switching clock, instead of directly from the main 10MHz clock. Use this to generate both the receiver switch-control signals, and the corresponding slave and *Data Dispatcher* signals, excluding the **blank** signal.

Also have the rising edge of the phase-switching clock load the roundtrip delay down-counter, which is decremented at each 10MHz clock cycle, until it underflows.

2. Whenever the roundtrip down-counter underflows, latch the slave and *Data Dispatcher* control signals from the main state generator, into registers whose outputs go to the corresponding inputs of the slaves and the *Data Dispatcher*.

At the same time, load a count of the number of samples that must be blanked, into a down-counter whose underflow output is used to drive the **blank** inputs of the slaves, via a *not* gate, and which is decremented by one at each 10MHz clock cycle, until the underflow output is asserted.

In summary, while most of the signals are delivered by what are essentially a single entry shift registers, clocked by the slow phase-switching clock signal, the **blank** signals are generated in the slave time-domain, from information latched from the start of each phase-switch cycle.

The settling time delays

The round-trip delay described above only encompasses the time that passes before the initial effects of a switch transition become apparent. It doesn't include the time taken for the effect of a switch to reach a settled state, after it starts changing. Unlike the round-trip delay, the settling-time delay depends on what is switching, and in the case of the cal-diodes,

whether it is being switched on or off. In particular, it seems likely that the switch-on time of the cal-diodes could be significantly greater than their switch-off time, due to thermal and loading effects when they are turned on. In practice the rise and fall times of the diodes, and the settling times of the phase-switches, are configurable via configuration registers, so there are no built-in assumptions about their relative magnitudes. When one or more switches are toggled, the overall settling time is determined by the switch with the longest settling time.

When the calibration diode switches are toggled, all subsequent integrations that fall within the settling time of the cal signal, are flagged in the data stream that is sent to the computer. This is achieved by holding the `stable` input-signal of the *Data Dispatcher* low.

During the settling time of phase-switch transitions, the `blank` input signal of the slaves are asserted, to arrange for affected ADC samples to be excluded from the integration sums.

3.3.4 Clock Conditioner

still TBD